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Author Index

Aballe, L., A. Barinov, A. Locatelli, S. Heun, S.		Ben Jaballah, A., M. Saadoun, M. Hajji, H.	
Cherifi and M. Kiskinova, Spectromicro-		Ezzaouia and B. Bessaïs, Silicon dissolu-	
scopy of ultrathin Pd films on W(1 1 0):.		tion regimes from chemical vapour etching:	
interplay of morphology and electronic		from porous structures to silicon grooving	238 (2004) 199
structure	238 (2004) 138	Ben Rabha, M., see Aouida, S.	238 (2004) 193
Abdat, M., see Gaillard, F.	238 (2004) 91	Benavente, J., see Váquez, M.I.	238 (2004) 415
Adachi, K., see Tsuji, H.	238 (2004) 132	Benzarti, K., see Baeta Neves, I.	238 (2004) 523
Afrin, R., S. Okazaki and A. Ikai, Force spec-	()	Bernabeu, E., see Martinez-Antón, J.C.	238 (2004) 380
troscopy of covalent bond rupture versus		Bernabeu, E., see Siegmann, P.	238 (2004) 375
protein extraction	238 (2004) 47	Bersani, M., see Iacob, E.	238 (2004) 24
Aimo Boot, E., see Ricciardi, C.	238 (2004) 331	Bessaïs, B., see Aouida, S.	238 (2004) 193
Allenspach, P., see Gupta, R.	238 (2004) 254	Bessaïs, B., see Ben Jaballah, A.	238 (2004) 199
Al-Mamun, and A.B.M.O. Islam, Characteriza-	200 (2001) 201	Bethencourt, M., F.J. Botana, M.J. Cano and M.	200 (2001) 177
tion of copper selenide thin films deposited		Marcos, Advanced generation of green con-	
by chemical bath deposition technique	238 (2004) 184	version coatings for aluminium alloys	238 (2004) 278
Almeida Neves, B.R., see Silva, G.G.	238 (2004) 64	Bieniaś, J., see Surowska, B.	238 (2004) 288
Almeida, A.M., see Ramos, M.M.D.	238 (2004) 438	Blanco, C., see Pesquera, C.	238 (2004) 320
Almeida, B.G., A. Pietka and J.A. Mendes,	200 (2001) 100	Bloisi, F., A.C. Barone and L. Vicari, Dry laser	250 (2001) 520
Infrared characterization of strontium tita-		cleaning of mechanically thin films	238 (2004) 121
nate thin films	238 (2004) 395	Bontempi, E., see Patelli, A.	238 (2004) 262
Anderle, M., see Iacob, E.	238 (2004) 24	Borisko, V.N., see Sadowski, M.J.	238 (2004) 433
Ania, C.O., see Parra, J.B.	238 (2004) 304	Botana, F.J., see Bethencourt, M.	238 (2004) 278
Antoniuk, O.A., see Vitusevich, S.A.	238 (2004) 143	Botta, D., see Chiodoni, A.	238 (2004) 485
Aouida, S., M. Saadoun, M.F. Boujmil, M. Ben	250 (2001) 115	Boujmil, M.F., see Aouida, S.	238 (2004) 193
Rabha and B. Bessaïs, Effect of UV irradia-		Bruque, J.M., see Méndez-Vilas, A.	238 (2004) 18
tions on the structural and optical features		Butsugan, M., see Sekine, Y.	238 (2004) 14
of porous silicon: application in silicon		Byrka, O.V., see Sadowski, M.J.	238 (2004) 433
solar cells	238 (2004) 193	Dyria, o. v., see badowsia, viio	200 (2001) 100
Arai, N., see Tsuji, H.	238 (2004) 132	Caballero, R., and C. Guillén, Structural and	
Arenillas, A., see Parra, J.B.	238 (2004) 304	morphological properties of Cu(In, Ga)Se ₂	
Ariza, M.J., see Váquez, M.I.	238 (2004) 415	thin films on Mo substrate	238 (2004) 180
Table, Marie, See Audues, Marie	250 (2001) 115	Cabezas, M.G., A. Bateni, J.M. Montanero and	
		A.W. Neumann, A new drop-shape metho-	
Baeta Neves, I., M. Chabut, C. Perruchot, M.M.		dology for surface tension measurement	238 (2004) 480
Chehimi and K. Benzarti, Interfacial inter-		Cáceres, D.A., see Larena, A.	238 (2004) 273
actions of structural adhesive components		Cáceres, D.A., see Larena, A.	238 (2004) 518
with cement pastes. Studies by inverse gas		Calliari, L., see Speranza, G.	238 (2004) 117
chromatography (IGC)	238 (2004) 523	Calvino-Casilda, V., see Durán-Valle, C.J.	238 (2004) 97
Ballarini, V., see Chiodoni, A.	238 (2004) 485	Calzado-Montero, R., see Méndez-Vilas, A.	238 (2004) 18
Baranov, A.M., see Speranza, G.	238 (2004) 117	Camerlingo, C., see Chiodoni, A.	238 (2004) 485
Baranowski, J., see Sadowski, M.J.	238 (2004) 433	Cano, M.J., see Bethencourt, M.	238 (2004) 278
Barinov, A., see Aballe, L.	238 (2004) 138	Cardona-Bedoya, J.A., A. Cruz-Orea, J.G.	(,
Barone, A.C., see Bloisi, F.	238 (2004) 121	Mendoza-Alvarez, Lucero Gomez-Herrera	
Barozzi, M., see Iacob, E.	238 (2004) 24	M., M.H. Farias and J.A. Diaz, Study of	
Barucca, G., see Ricciardi, C.	238 (2004) 331	GaN_xAs_{1-x} semiconducting films grown by	
Bateni, A., see Cabezas, M.G.	238 (2004) 480	laser pulsed deposition on crystalline and	
Belhousse, S., see Cheraga, H.	238 (2004) 495	amorphous substrates	238 (2004) 147
Belyaev, A.E., see Vitusevich, S.A.	238 (2004) 143	Cardona-Bedoya, J.A., see Diaz-Reyes, J.	238 (2004) 400

Casado, J., see Váquez, M.I.	238 (2004) 415	Dian, J., A. Macek, D. Nižňanský, I. Němec, V.	
Chabut, M., see Baeta Neves, I.	238 (2004) 523	Vrkoslav, T. Chvojka and I. Jelínek, SEM	
Chaudhari, A., CC. Sanders Yan and SL.		and HRTEM study of porous silicon-rela-	
Lee, Multifractal analysis of growing sur-		tionship between fabrication, morphology	
faces	238 (2004) 513	and optical properties	238 (2004) 169
Chaudhari, S.M., see Gupta, R.	238 (2004) 254	Diaz, J.A., see Cardona-Bedoya, J.A.	238 (2004) 147
Chehimi, M.M., see Baeta Neves, I.	238 (2004) 523	Diaz-Reyes, J., J.L. Herrera-Perez, M.L.	
Chen, SY., CS. Hsiao and JJ. Hsu, Inter-		Gomez-Herrera, J.A. Cardona-Bedoya	
facial microstructure and electrical proper-		and J.G. Mendoza-Alvarez, Photolumines-	
ties of PT/Al ₂ O ₃ /Si annealed at high		cence studies in highly Te-doped	
temperatures	238 (2004) 429	$Ga_{1-x}In_xAs_ySb_{1-y}$ epitaxial layers grown	
Chen, SY., see Lin, CC.	238 (2004) 405	on GaSb by liquid phase epitaxy	238 (2004) 400
Cheng, SY., see Lin, CC.	238 (2004) 405	Drobek, T., M. Reiter and W.M. Heckl, Scan-	
Chen-Mayer, H.H., see Lamaze, G.P.	238 (2004) 108	ning probe microscopy experiments in	
Cheraga, H., S. Belhousse and N. Gabouze,		microgravity	238 (2004) 3
Characterization of a new sensing device		Durán-Valle, C.J., S. Ferrera-Escudero, V. Cal-	,
based on hydrocarbon groups (CH _x) coated		vino-Casilda, J. Díaz-Terán and R.M. Mar-	
porous silicon	238 (2004) 495	tín-Aranda, The effect of ultrasound on the	
Cherifi, S., see Aballe, L.	238 (2004) 138	catalytic activity of alkaline carbons: pre-	
Chiasera, A., see Speranza, G.	238 (2004) 117	paration of N-alkyl imidazoles	238 (2004) 97
Chiodoni, A., V. Ballarini, D. Botta, C. Camer-	200 (200 1) 111	parametric of the analysis and analysis analysis and analysis analysis and analysis analysis and analysis analysis and analysis analysis and analysis anal	250 (2001) 71
lingo, F. Fabbri, S. Ferrari, R. Gerbaldo, G.		Elefant, D., see Kozhuharova, R.	238 (2004) 355
Ghigo, L. Gozzelino, F. Laviano, B. Mine-		Evarestov, R.A., E.A. Kotomin, D. Fuks, J.	250 (2004) 555
tti, C.F. Pirri, G. Tallarida, E. Tresso and E.		Felsteiner and J. Maier, Ab initio calcula-	
Mezzetti, Characterization of silicon–		tions of the LaMnO ₃ surface properties	238 (2004) 457
YBCO buffered multilayers grown by sput-		Ezzaouia, H., see Ben Jaballah, A.	238 (2004) 199
tering	238 (2004) 485	Ezzaoula, II., see Bell Jaballali, A.	238 (2004) 199
Choi, M.C., see Yoon, TY.	238 (2004) 483	Fabbri, F., see Chiodoni, A.	238 (2004) 485
Chvojka, T., see Dian, J.	238 (2004) 299	Fanchenko, S.S., see Speranza, G.	238 (2004) 483
Cohen-Taguri, G., see Goldfarb, I.	238 (2004) 109	Farias, M.H., see Cardona-Bedoya, J.A.	238 (2004) 117
Conrad, J., see Wilms, M.			238 (2004) 147
	238 (2004) 490	Farjas, J., C. Rath, P. Roura and P. Roca i	
Corbacho, I., see Méndez-Vilas, A.	238 (2004) 51	Cabarrocas, Crystallization kinetics of	
Correia, H.M.G., see Ramos, M.M.D.	238 (2004) 438	hydrogenated amorphous silicon thick	
Cruz Hernández, N., and J.F. Sanz, First prin-		films grown by plasma-enhanced chemical	220 (2004) 1/5
ciples simulations of Cu and Au deposition	220 (2004) 220	vapour deposition	238 (2004) 165
on α -Al ₂ O ₃ (0 0 0 1) surface	238 (2004) 228	Felsteiner, J., see Evarestov, R.A.	238 (2004) 457
Cruz-Orea, A., see Cardona-Bedoya, J.A.	238 (2004) 147	Fernández González, C., see Díaz-Díez, M.A.	238 (2004) 309
Cuerda-Correa, E.M., see Díaz-Díez, M.A.	238 (2004) 309	Ferrari, M., see Speranza, G.	238 (2004) 117
D . NO LEGIU . E O BOOT		Ferrari, P., see Tessarolo, F.	238 (2004) 341
Dantas, N.O., A.F.G. Monte, F. Qu, R.S. Silva		Ferrari, S., see Chiodoni, A.	238 (2004) 485
and P.C. Morais, Energy transfer in PbS		Ferrera-Escudero, S., see Durán-Valle, C.J.	238 (2004) 97
quantum dots assemblies measured by		Ferrero, S., see Mandracci, P.	238 (2004) 336
means of spatially resolved photolumines-		Fuentes, A., see Larena, A.	238 (2004) 518
cence	238 (2004) 209	Fuks, D., see Evarestov, R.A.	238 (2004) 457
Danylyuk, S.V., see Vitusevich, S.A.	238 (2004) 143		
Díaz-Díez, M.A., see Gañan, J.	238 (2004) 347	Gabouze, N., see Cheraga, H.	238 (2004) 495
Díaz-Díez, M.A., V. Gómez-Serrano, C. Fer-		Gaillard, F., M. Abdat, J.P. Joly and A. Perrard,	
nández González, E.M. Cuerda-Correa and		An intermittent temperature-programmed	
A. Macías-García, Porous texture of acti-		desorption method for studying kinetics	
vated carbons prepared by phosphoric acid		of desorption from heterogeneous surfaces	238 (2004) 91
activation of woods	238 (2004) 309	Galán, P., see Váquez, M.I.	238 (2004) 415
Díaz-Terán, J., see Durán-Valle, C.J.	238 (2004) 97	Gallardo-Moreno, A.M., see Méndez-Vilas, A.	238 (2004) 18
de Freitas Rocha, P.M., see Silva, G.G.	238 (2004) 64	Gañan, J., C.M. González-García, J.F. Gonzá-	
de Oliveira, P.S., see Silva, G.G.	238 (2004) 64	lez, E. Sabio, A. Macías-García and M.A.	
De Pablos, A., see Polanco, R.	238 (2004) 506	Díaz-Díez, Preparation of activated carbons	
Del Rosario, G., S. Ohara, L. Mancic and O.		from bituminous coal pitches	238 (2004) 347
Milosevic, Characterisation of YAG:Ce		García-Jareño, J.J., D. Giménez-Romero and F.	
powders thermal treated at different tem-		Vicente, Singular points of electrochemical	
peratures	238 (2004) 469	impedance function	238 (2004) 449
Depero, L.E., see Patelli, A.	238 (2004) 262	Gerbaldo, R., see Chiodoni, A.	238 (2004) 485

Gimeine-Romero, D., see Ricciardi, C. Gioughis F., See Riciciardi, C. Gioughis F., See Riciardi, C. Gioughis F., See Grana, J. Golfard, J. S., Gorssman, G. Cohen-Taguri and M. Levinshiein, Scanning tumeling micro- scopy of timinium silicide annoislands Gómee, G., see Ocaña, J.I. Gómez-Berran, M.L., see Diaz-Reyes, J. Gómez-Berran, M.L., see Diaz-Reyes, J. Gómez-Berran, M.L., see Diaz-Reyes, J. Gornzilez, J.F., see Gañan, J. Gornzilez, J.F., see Gañan, J. Gornzilez-Martín, M.L., see Méndez-Vilas, A. Gornzilez-Martín, M.L., see Mendez-Vilas, A. Gornzilez-Martín, M.L., see Méndez-Vilas, A. Gornzilez-Martín, M.L., see Mendez-Vilas, A. Gornzi	Ghigo, G., see Chiodoni, A.	238 (2004) 485	Hsu, JJ., see Chen, SY.	238 (2004) 429
Gildrich, L.S. Grossman, G. Cohen-Taguri and M. Levinsbrinis, Scanning tumeling microscopy of timinum siticide annosidands Gómez, G. see Ocaña, J. Gómez-Berran, M. L., see Diaz-Reyes, J. Gómez-Serrano, V., see Diaz-Dicz, M.A. 288 (2004) 509 (388 (2004) 509 (360 (2004) 289 (2004) 500 (360 (2004) 289 (2004) 500 (360 (2004) 289 (2004) 500 (360 (2004) 289 (2004) 500 (360 (2004) 289 (2004) 500 (360 (2004) 289 (2004) 500 (360 (2004) 289 (2004) 500 (360 (2004) 289 (2004) 500 (360 (2004) 289 (2004) 500 (360 (2004) 289 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500 (360 (2004) 500				
Goldrárh, I. S. Grossman, G. Cohen-Taguri and M. Levinshtein, Scanning tumenleing microscopy of titanium silicide nanoislands (Gómez, G. See Coaña, J. Gonez-Herrera, M.I., see Diaz-Reyes, J. 238 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 228 (2004) 309 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (2004) 229 (20	Giorgis, F., see Ricciardi, C.	238 (2004) 331		
Levinstrein, Scamming tunneling mirroscopy of timinum silicide monishands 238 (2004) 29 238 (2004) 301 328 (2004) 302 328 (2004) 302 328 (2004) 302 328 (2004) 303 328 (2004) 303 328 (2004) 303 328 (2004) 303 328 (2004) 304 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305 328 (2004) 305	Giubertoni, D., see Iacob, E.	238 (2004) 24		
238 (2004) 295	Goldfarb, I., S. Grossman, G. Cohen-Taguri and			
Gómez-Germo, V., see Díaz-Díez, M.A. Gómez-Sermo, V., see Díaz-Díez, M.A. Gómzález, F., see Sequera, C. Gómzález-García, C.M., see Gánan, J. Gómzález-García, C.M., see Gánan, J. Gómzález-Martín, M.L., see Méndez-Vilas, A. Gómzález-Martín, M.L., see Mínhartín, M.Gupta, A. Gómzález-Martín, M.L., see Méndez-Vilas, A. Gómzález-Martín, M.L., see Mández-Vilas, A. Gómzález-Martí	M. Levinshtein, Scanning tunneling micro-			
Gómez-G. G., see Posagera, M.L., see Díaz-Reyes, J. Gómez-Serrano, V., see Díaz-Díez, M.A. Gómzález, J., see Posagera, C. Gómzález, J.F., see Gafana, J. Gómzález-Marcín, M.L., see Méndez-Vilas, A. Gómzález-Marcín, M.L., see Mández-Vilas, A. G	scopy of titanium silicide nanoislands	238 (2004) 29		238 (2004) 113
Gómez-Serramo, V., see Posquera, C. 238 (2004) 309 238 (2004) 324 238 (2004) 324 238 (2004) 324 238 (2004) 324 238 (2004) 327 238 (2004) 327 238 (2004) 327 238 (2004) 327 238 (2004) 327 238 (2004) 327 238 (2004) 327 238 (2004) 327 238 (2004) 327 238 (2004) 327 238 (2004) 327 238 (2004) 327 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328 238 (2004) 328		238 (2004) 501		
González, J.F., see Gañan, J. (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 347 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348 (238 (2004) 348	Gomez-Herrera, M.L., see Diaz-Reyes, J.	238 (2004) 400		
González-García, C.M., see Gañan, J. González-García, C.M., see Gañan, J. González-García, C.M., see Méndez-Vilas, A. 238 (2004) 17 González-Martín, M.L., see Méndez-Vilas, A. 238 (2004) 18 González-Martín, M.L., see Méndez-Vilas, A. González-Martín, M.L., see Mendez-Vilas, A. González-Martín, M.L., see Mendez-Vilas, A. González-Martín, M.L., see Mendez-Vilas, A. González-Martín, M.L., see Martinez-Antón, J.C. Gotoh, Y., see Tsauji, H. González-Martín, M.L., see Martinez-Antón, J.C. Gotoh, Y., see Tsauji, H. González-Martín, M.L., see Martinez-Antón, J.C. Gorder-Sae, S. S., see Chalajeo, D. 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238 (2004) 380 238	Gómez-Serrano, V., see Díaz-Díez, M.A.	238 (2004) 309	The state of the s	, , , , , , , , , , , , , , , , , , , ,
González-Martín, M.L., see Méndez-Vilas, A. González-Martín, M.L., see Mártínez-Antón, J.C. González-Martín, M.L., see Mártínez-Martín, M.L., see Mártínez-Antón, J.C. González-Martín, M.L., see Mino, L. 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 23	González, F., see Pesquera, C.	238 (2004) 320		
Somzaliez-Martin, M.L., see Méndez-Vilas, A Conzaliez-Martin, M.L., see Mendez-Vilas, A Conzaliez-Martin, M.L., see Martinez-Antón, J.C. Gotoh, Y, see Tsusii, H. Conzaliez-Martin, M.L., see Martinez-Antón, J.C. Gotoh, Y, see Susii, H. Conzaliez-Martin, M.L., see Martinez-Antón, J.C. Gotoh, Y, see Sac Malla, A. (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (238 (2004) 152 (González, J.F., see Gañan, J.	238 (2004) 347		
González-Martín, M.L., see Méndez-Vilas, A. Conzález-Martín, M.L., see Mindez-Vilas, A. Conzález-Martín, M.L.,	González-García, C.M., see Gañan, J.	238 (2004) 347		
Sounzalez-Martín, M.L., see Méndez-Vilias, A. Conzalez-Martín, M.L., see Méndez-Vilias, A. Conzalez-Moreno, R., see Martínez-Antón, J.C. Cotoh, Y., see Tsuji, H. Cozzelino, L., see Chiodoni, A. Cardín, A., see Chiodoni, A. Cardín, A., see Kozuhuharova, R. Greene, G., and R. Tannenbaum, Adsorbtion of polyelectrolyte multilayers on plasma-modified porous polyethylene Grossman, S., see Goldfarb, I. 238 (2004) 385 (238 (2004) 385 (238 (2004) 385 (238 (2004) 385 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 2	González-Martín, M.L., see Méndez-Vilas, A.	238 (2004) 1		
González-Martín, M.L., see Méndez-Vilas, A. González-Martín, M.L., see Mártínez-Antón, J.C. 328 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 380 (2004) 380 3	González-Martín, M.L., see Méndez-Vilas, A.	238 (2004) 9		*
Conzalez-Martín, M.L., see Méndez-Vilas, A.	González-Martín, M.L., see Méndez-Vilas, A.	238 (2004) 18		
S. Nishio, K. Yasuda and Y. Ishigami, Ion beam synthesis of 3C-SiC layers in Si and its application in buffer layer for GaN epitaxial growth plants and polyethylene Crossman, S., see Goldfarb, I. 238 (2004) 135	González-Martín, M.L., see Méndez-Vilas, A.	238 (2004) 42		238 (2004) 295
J.C. 238 (2004) 380 238 (2004) 380 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485 238 (2004) 485	González-Martín, M.L., see Méndez-Vilas, A.	238 (2004) 51		
Soroli, Y., see Tsuji, H. 238 (2004) 132 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004) 135 138 (2004)	González-Moreno, R., see Martinez-Antón,			
Gozzelino, L., see Chiodoni, A. 238 (2004) 485 Graff, A., see Kozhuharova, R. 238 (2004) 485 Greene, G., and R. Tannenbaum, Adsorbtion of polyelectrolyte multilayers on plasma-modified porous polyethylene Grossman, S., see Goldfarb, I. 238 (2004) 29 Groudeva-Zotova, S., see Kozhuharova, R. Guarrera, G.M., see Tesrasorlo, F. Guarrera, G.M., see Tesrasorlo, F. Guillén, A., see Zamora-Peredo, L. Cuillén, C., see Caballero, R. 238 (2004) 254 Gupta, A., see Gupta, R. 238 (2004) 254 Gupt	J.C.	238 (2004) 380		
Graff, A., see Kozhuharova, R. 238 (2004) 355 Iwata, M., see Miao, L. 238 (2004) 125 Greene, G., and R. Tannenbaum, Adsorbtion of polyelectrolyte multilayers on plasmamodified porous polyethylene 238 (2004) 238 (2004) 254 Jaziri, S., see Tiriki, M. 238 (2004) 169 Groudeva-Zotova, S., see Kozhuharova, R. 238 (2004) 254 Jaziri, S., see Tiriki, M. 238 (2004) 169 Jaziri, S., see Tiriki, M. 238 (2004) 180 Jaziri, S., see Tariki, M. 238 (2004) 180 Jaziri, S., see Tiriki, M. 238 (2004) 180 Jaziri, S., see Tariki, M. Jaziri, S., see Tiriki, M. 238 (2004) 180 Jaziri, S., see Tariki, M.	Gotoh, Y., see Tsuji, H.	238 (2004) 132	**	
Greene, G., and R. Tannenbaum, Adsorbtion of polyelectrolyte multilayers on plasma modified prorous polyelythylene Grossman, S., see Goldfarb, I. Groudeva-Zottova, S., see Kozhuharova, R. Guarrera, G.M., see Tessarolo, F. Guillén, C., see Caballero, R. Guillén, C., see Caballero, R. Guillén, C., see Caballero, R. Gupta, R., a Gupta, S.M. Chaudhari, M. Gupta and P. Allenspach, Study of interfacial properties and its effect on magnetization behaviour of Fe/Ni multilayer structure Guraya, M., S. Sprenger, W. Rarog-Pilecka, D. Szmigiel, Z. Kowalczyk and M. Muhler. The effect of promoters on the electronic structure of ruthenium catalysts supported on carbon 238 (2004) 199 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (2004) 254 238 (20	Gozzelino, L., see Chiodoni, A.	238 (2004) 485		
Deliver multilayers on plasma-modified porous polyethylene 238 (2004) 101 238 (2004) 219 238 (2004) 219 238 (2004) 219 238 (2004) 219 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004) 215 238 (2004)	Graff, A., see Kozhuharova, R.	238 (2004) 355	Iwata, M., see Miao, L.	238 (2004) 125
Sample S	Greene, G., and R. Tannenbaum, Adsorbtion of		Tarkhala A and Walada A	229 (2004) 155
See Goldfarb, I. 238 (2004) 29 Jelfnek, I., see Dian, J. 238 (2004) 29 Jeng, C., see Yoon, TY. 238 (2004) 29 Jeng, C., see Joon, TY. 2	polyelectrolyte multilayers on plasma-			
Groudew-Zotova S., see Kozhuharova, R. 238 (2004) 355 238 (2004) 355 238 (2004) 355 238 (2004) 355 238 (2004) 355 238 (2004) 355 238 (2004) 355 238 (2004) 204 238 (2004) 204 238 (2004) 204 238 (2004) 204 238 (2004) 204 238 (2004) 204 238 (2004) 204 238 (2004) 204 238 (2004) 204 238 (2004) 204 238 (2004) 204 238 (2004) 204 238 (2004) 204 238 (2004) 204 238 (2004) 204 238 (2004) 204 238 (2004) 204 238 (2004) 204 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205 238 (2004) 205	modified porous polyethylene	238 (2004) 101		
Guarrara, G.M., see Tessarolo, F. Guillén, A., see Zamora-Peredo, L. Guillén, C., see Caballero, R. Guillén, A., see Gupta, R. Gupta, M., S. Sprenger, W. Rarog-Pilecka, D. Szmigiel, Z. Kowalczyk and M. Muhler, The effect of promoters on the electronic structure of ruthenium catalysts supported on carbon 238 (2004) 254 Hajji, M., see Ben Jaballah, A. Hakola, A., O. Heczko, A. Jaakkola, T. Kajava and K. Ullakko, Ni-Mn-Ga films on Si, GaAs and Ni-Mn-Ga single crystals by pulsed laser deposition Haron, S., see Nabok, A. Heckl, W.M., see Drobek, T. Heckl, W.M., see Drobek, T. Heun, S., see Aballe, L. Hino, T., T. Taguchi, Y. Yamauchi, Y. Hirohata and M. Nishikawa, Morphological change of polycrystalline copper after ion irradiation followed by annealing 238 (2004) 444 Hirohata, Y., see Hino, T. Horino, Y., see Fisubakino, H. 238 (2004) 464 238 (2004) 254 Jiménez-Rodríguez, J.J., see Jaid-Ettaoussi, M. Jiménez-Sáez, J.C., A.M.C. Pérez-Martín and J.J. Jiménez-Sáez, J.C., see Said-Ettaoussi, M. Jiménez-Sáez, J.C., see Said-Ettaoussi, M. Jiménez-Sáez, J.C., see Maid-Ettaoussi, M. Jiménez-Sáez, J.C., see Said-Ettaoussi, M. Jin, P., see Gaillard, F. Jurzyszyn, L., see Stankiewicz, B. 238 (2004) 95 Kajava, T., see Hakola, A. Kamiński, W., see Stankiewicz, B. Kajava, T., see Hakola, A. Kamiński, W., see Stankiewicz, B. Kajava, T., see Hakola, A. Kamiński, W., see Kovalyova, L.A. Kamiński, W., see Kovalyova, L.A. Kamiński, W., see Stankiewicz, B. Z38 (2004) 155 Kaneko, K., see Miao, L. Z38 (2004) 155 Kaneko, K., see Miao	Grossman, S., see Goldfarb, I.	238 (2004) 29		
Guilfen, C., see Caballero, R. 238 (2004) 204 Guilfen, C., see Caballero, R. 238 (2004) 204 Guilfen, C., see Caballero, R. 238 (2004) 254 Gupta, A., see Gupta, R. 238 (2004) 254 Gupta, R., A. Gupta, S.M. Chaudhari, M. Gupta and P. Allenspach, Study of interfacial properties and its effect on magnetization behaviour of Fe/Ni multilayer structure Guraya, M., S. Sprenger, W. Rarog-Pilecka, D. Szmigiel, Z. Kowalczyk and M. Muhler, The effect of promoters on the electronic structure of ruthenium catalysts supported on carbon 238 (2004) 279 (238 (2004) 279 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (238 (2004) 254 (Groudeva-Zotova, S., see Kozhuharova, R.	238 (2004) 355		
Guillén, C., see Caballero, R. 238 (2004) 180 Gupta, A., see Gupta, R. Gupta, M., See Gupta, R. Gupta, R., A Gupta, S.M. Chaudhari, M. Gupta and P. Allenspach, Study of interfacial properties and its effect on magnetization behaviour of Fe/Ni multilayer structure Guraya, M., S. Sprenger, W. Rarog-Pilecka, D. Szmigiel, Z. Kowalczyk and M. Muhler, The effect of promoters on the electronic structure of ruthenium catalysts supported on carbon 238 (2004) 254 Haiji, M., see Ben Jaballah, A. Hakola, A., O. Heczko, A. Jaakkola, T. Kajava and K. Ullakko, Ni-Mn-Ga films on Si, GaAs and Ni-Mn-Ga single crystals by pulsed laser deposition Haron, S., see Nabok, A. Heckl, W.M., see Drobek, T. Heczko, O., see Hakola, A. Heckl, W.M., see Drobek, T. Herera-Perez, J.L., see Diaz-Reyes, J. Herera-Perez, J.L., see Diaz-Reyes, J. 238 (2004) 423 238 (2004) 254 Simenez-Rodríguez, J.J., see Said-Ettaoussi, M. Jiménez-Sáez, J.C., a.M.C. Pérez-Martín and J.J. Jiménez-Rodríguez, Molecular dynamics simulation of Cu cluster deposition on Au(0 01) surfaces Jimenez-Saez, J.C., a.M.C. Pérez-Martín and J.J. Jiménez-Rodríguez, Molecular dynamics simulation of Cu cluster deposition on Au(0 01) surfaces Jimenez-Rodríguez, J.J., see Said-Ettaoussi, M. Jiménez-Sáez, J.C., a.M.C. Pérez-Martín and J.J. Jiménez-Saez, J.C., see Said-Ettaoussi, M. Jinín, P., see Tanemura, S. Kajava, T., see Hakola, A. Kaniński, W., see Stankiewicz, B. Zas (2004) 155 Kaneko, K., see Miao, L. Kaneko, K., see M	Guarrera, G.M., see Tessarolo, F.	238 (2004) 341		238 (2004) 330
Gupta, A., see Gupta, R. Gupta, M., see Gupta, R. Gupta, M., see Gupta, S.M. Chaudhari, M. Gupta and P. Allenspach, Study of interfacial properties and its effect on magnetization behaviour of Fe/Ni multilayer structure Guraya, M., S. Sprenger, W. Rarog-Pilecka, D. Szmigiel, Z. Kowalczyk and M. Muhler, The effect of promoters on the electronic structure of ruthenium catalysts supported on carbon 238 (2004) 254 Haiji, M., see Ben Jaballah, A. Hakola, A., O. Heczko, A. Jaakkola, T. Kajava and K. Ullakko, Ni-Mn-Ga films on Si, GaAs and Ni-Mn-Ga single crystals by pulsed laser deposition 4238 (2004) 254 Beckl, W.M., see Drobek, T. Heckl, W.M., see Drobek, T. Herrera-Perez, J.L., see Diaz-Reyes, J. Herrera-Perez, J.L., see Diaz-Reyes, J. Henn, S., see Aballe, L. Hino, T., T. Taguchi, Y. Yamauchi, Y. Hirohata and M. Nishikawa, Morphological change of polycrystalline copper after ion irradiation followed by annealing of polycrystalline copper after ion irradiation followed by annealing of polycrystalline copper after ion irradiation followed by annealing for the properties and its effect on magnetization behaviour of Fe/Ni multilayer structure of multilayer structure dynamics simulation of Cu cluster deposition on Au(0 1) Isurfaces Jimenez-Saez, J.C., see Said-Ettaoussi, M. Jiménez-Rodriguez, J.J., see Said-Ettaoussi, M. Jujurfaces Jiménez-Saez, J.C., see Said-Ettaoussi, M. Jiménez-Sáez, J.C., see Said-Ettaoussi, M. Jin, Jufaces Jiménez-Sáez, J.C., see Said-Ettaouss	Guillén, A., see Zamora-Peredo, L.	238 (2004) 204		228 (2004) 222
Gupta, M., see Gupta, R. Gupta, M., see Gupta, R. Gupta, M., see Gupta, R. Gupta, M., see Gupta, S. Gupta, S. Gupta, M., See Gupta, S. Gupta, S. Gupta, S. Gupta, M., See Gupta, S. Gupta, S. Gupta, S. Gupta, S. Gupta, M., See Stankiewicz, B. Gupta, S. Gupta, S. Gupta, M., See Stankiewicz, B. Gupta, S. Gupta, S. Gupta, S. Gupta, M., See Stankiewicz, B. Gupta, S. Gupta, S. Gupta, M., See Miao, L. Gupta, M., See Miao, L. Gupta, M., See Miao, L. Gupta, M., See Stankiewicz, B. Gupta, M., See Miao, L. Gu	Guillén, C., see Caballero, R.	238 (2004) 180		
Gupta, R., See Cupta, R. Gupta and P. Allenspach, Study of interfacial properties and its effect on magnetization behaviour of Fe/Ni multilayer structure Guraya, M., S. Sprenger, W. Rarog-Pilecka, D. Szmigiel, Z. Kowalczyk and M. Muhler, The effect of promoters on the electronic structure of ruthenium catalysts supported on carbon 238 (2004) 254 Bajji, M., see Ben Jaballah, A. Hakola, A., O. Heczko, A. Jaakkola, T. Kajava and K. Ullakko, Ni-Mn-Ga films on Si, GaAs and Ni-Mn-Ga single crystals by pulsed laser deposition Baron, S., see Nabok, A. 238 (2004) 429 Heczko, O., see Hakola, A. 238 (2004) 429 Heczko, O., see Hakola, A. 238 (2004) 429 Herrera-Perez, J.L., see Diaz-Reyes, J. Hino, T., T. Taguchi, Y. Yamauchi, Y. Hirohata and M. Nishikawa, Morphological change of polycrystalline copper after ion irradiation followed by annealing of polycrystalline copper after ion irradiation followed by annealing 1238 (2004) 464 Finshata, Y., see Hino, T. 238 (2004) 464 Finshata, Y., see Fundamics simulation of Cu cluster deposition on Cu cluster deposition on Aud Chalada, A. See Stankiewicz, B. 238 (2004) 464 Finshata, Y., see Fundamics, M.O. 193 (2004) 464 Finshata, Y	Gupta, A., see Gupta, R.	238 (2004) 254		238 (2004) 249
dynamics simulation of Cu cluster deposition on Au(0 01) surfaces Allenspach, Study of interfacial properties and its effect on magnetization behaviour of Fe/Ni multilayer structure Guraya, M., S. Sprenger, W. Rarog-Pilecka, D. Szmigiel, Z. Kowalczyk and M. Muhler, The effect of promoters on the electronic structure of ruthenium catalysts supported on carbon 238 (2004) 254 Jimenez-Saez, J.C., see Said-Ettaoussi, M. Jin, P., see Tanemura, S. Joly, J.P., see Gaillard, F. Jurczyszyn, L., see Stankiewicz, B. Joly, J.P., see Gaillard, F. Jurczyszyn, L., see Stankiewicz, B. Joly, J.P., see Gaillard, F. Jurczyszyn, L., see Stankiewicz, B. Joly, J.P., see Hakola, A. Kamiński, W., see Stankiewicz, B. Lakamiński, W., see Stankiewicz, B. Lak	Gupta, M., see Gupta, R.	238 (2004) 254		
and P. Allenspach, Study of Interfacial properties and its effect on magnetization behaviour of Fe/Ni multilayer structure Guraya, M., S. Sprenger, W. Rarog-Pilecka, D. Szmigiel, Z. Kowalczyk and M. Muhler, The effect of promoters on the electronic structure of ruthenium catalysts supported on carbon 238 (2004) 254 Majji, M., see Ben Jaballah, A. Hakola, A., O. Heczko, A. Jaakkola, T. Kajava and K. Ullakko, Ni-Mn-Ga films on Si, GaAs and Ni-Mn-Ga single crystals by pulsed laser deposition Haron, S., see Nabok, A. Heckl, W.M., see Drobek, T. Heczko, O., see Hakola, A. Heczko, O., see Hakola, A. Herra-Perez, J.L., see Diaz-Reyes, J. Herra-Perez, J.L., see Diaz-Reyes, J. Hino, T., T. Taguchi, Y. Yamauchi, Y. Hirohata and M. Nishikawa, Morphological change of polycrystalline copper after ion irradiation followed by annealing 1 tion on Au(0 0 1) surfaces Jimenez-Saez, J.C., see Said-Ettaoussi, M. Jin, P., see Tanemura, S. Joly, J.P., see Gaillard, F. 238 (2004) 254 Jimenez-Saez, J.C., see Said-Ettaoussi, M. Jin, P., see Tanemura, S. 238 (2004) 490 Kajava, T., see Hakola, A. Kajava, T., see Hakola, A. Kamiński, W., see Stankiewicz, B. Kajava, T., see Hakola, A. Kamiński, W., see Stankiewicz, B. Z38 (2004) 125 Kaneko, K., see Miao, L. Z38 (2004) 125 Xaneko, K., see Miao, L. Xaneko, K., see Miao, L. Z38 (2004) 125 Xaneko, K., see Miao, L. Xaneko, K., see Miao, L. Z38 (2004) 125 Xaneko, K., see Miao, L. X	Gupta, R., A. Gupta, S.M. Chaudhari, M. Gupta			
Dimenz Saz J.C., see Said-Ettaousi, M. 238 (2004) 249	and P. Allenspach, Study of interfacial			229 (2004) 222
Suraya, M., S. Sprenger, W. Rarog-Pilecka, D. Szmigiel, Z. Kowalczyk and M. Muhler, The effect of promoters on the electronic structure of ruthenium catalysts supported on carbon 238 (2004) 77 Xajava, T., see Hakola, A. 238 (2004) 36 Xajava, T., see Hakola, A. 238 (2004) 155 Xajava, T., see Hakol	properties and its effect on magnetization			
Szmigiel, Z. Kowalczyk and M. Muhler, The effect of promoters on the electronic structure of ruthenium catalysts supported on carbon 238 (2004) 77 Kajava, T., see Hakola, A. 238 (2004) 36 Kaneko, K., see Miao, L. 238 (2004) 155 Kaneko, K., see Miao, L. 238 (2004) 175		238 (2004) 254		
Stringfer, Z. Rowards and M. Humber, The effect of promoters on the electronic structure of ruthenium catalysts supported on carbon 238 (2004) 77				
Structure of ruthenium catalysts supported on carbon 238 (2004) 77 Kajava, T., see Hakola, A. 238 (2004) 155 238 (2004) 36 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 126 238 (2004) 126 238 (2004) 126 238 (2004) 126 238 (2004) 126 238 (2004) 126 238 (2004) 126 238 (2004) 126 238 (2004) 126 238 (2004) 126 238 (2004) 126 238 (2004) 126 238 (2004) 126 238 (2004) 126 238 (2004) 126 238 (2004) 126 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (2004) 125 238 (20	Szmigiel, Z. Kowalczyk and M. Muhler,			
on carbon 238 (2004) 77 Kajava, I., see Hakola, A. Kamiński, W., see Stankiewicz, B. Kamiński, W., see Miao, L. 238 (2004) 125 Kaneko, K., see Miao, L. Kaneko, K., see Miao, L. Kaneko, K., see Miao, L. Sas (2004) 175 Khaydar, A.M., see Kovalyova, L.A. Sas (2004) 175 Khaydar, A.M., see Miao, L. Sas (2004) 175 Khaydar, A.M., see Miao, L. Sas (2004) 175 Khaydar, A.M., see Miao, L. Sas (2004) 175 Khaydar, A.M., see Kovalyova, L.A. Sas (2004) 475 Khaydar, A.M., see Kovalyova, L.A. Sas (2004) 475 Kiny, J.H., see Youn, TY. Sas (2004) 269 Kim, J.H., see Yoon, TY. Sas (2004) 269 Kim, J.H., see Yoon, TY. Sas (2004) 299 Herrera-Perez, J.L., see Diaz-Reyes, J. Sas (2004) 299 Herrera-Perez, J.L., see Diaz-Reyes, J. Sas (2004) 138 Kiricsi, I., see Ötvös, Zs. Sas (2004) 138 Kiskinova, M., see Stapinski, T. Sas (2004) 138 Kluska, S., see Stapinski, T. Sas (2004) 360 Kind, J.H., see Youn, TY. Sas (2004) 360 Kind, J.			Juiczyszyli, L., see Stalikiewicz, B.	238 (2004) 30
Kamiński, W., see Stankiewicz, B. Kaniński, W., see Stankiewicz, B. Kaneko, K., see Miao, L. Kaneko, L. Kaneko, L. Kaneko, K. Kaneko, K. Kaneko, K. Kaneko, K. Kaneko, K. Kaneko, K. Kaneko, L. Kaneko, L. Kaneko, L. Kaneko, L. Kaneko, L.	structure of ruthenium catalysts supported		Kajava T sas Hakala A	238 (2004) 155
Hajji, M., see Ben Jaballah, A. Hakola, A., O. Heczko, A. Jaakkola, T. Kajava and K. Ullakko, Ni–Mn–Ga films on Si, GaAs and Ni–Mn–Ga single crystals by pulsed laser deposition Haron, S., see Nabok, A. Heckl, W.M., see Drobek, T. Heczko, O., see Hakola, A. Herrera-Perez, J.L., see Diaz-Reyes, J. Herrera-Perez, J.L., see Diaz-Reyes, J. Hino, T., T. Taguchi, Y. Yamauchi, Y. Hirohata and M. Nishikawa, Morphological change of polycrystalline copper after ion irradiation followed by annealing Again M. Wasse Tsubakino, H. Kaneko, K., see Miao, L. Khaydar, A.M., see Kovalyova, L.A. Khaydar, A.M., see Kovalyova, L.A. Khaydar, A.M., see Kovalyova, L.A. Khayder, A.M., see Kovalyova, L.A. Khayder, A.M., see Kovalyova, L.A. Khaydar, A.M., see Kovalyova, L.A. Khayder, A.M., see Kovalyova, L.A. Khaydar, A.M., see Foon, TY. Khaydar, A.M., see Foon, TY. Kinydar, A.M., see Yoon, TY. Sal (2004) 269 Kim, J.H., see Yoon, TY. Kim, M.W., see Yoon, TY. Kim, M.W., see Tsubakino, H. Sal (2004) 269 Kim, M.W., see Yoon, TY. Kim, M.W., see Tsubakino, H. Sal (2004) 299 Kim, M.W., see Tsubakino, H. Sal (2004) 290 Kim, M.W., see Tsubakino, H. Sal (2004) 464 Kiricsi, I., see Öivös, Zs. Kiskinova, M., see Aballe, L. Sal (2004) 367 Kiskinova, M., see Stapinski, T. Sal (2004) 367 Kiskinova, M., see Stap	on carbon	238 (2004) 77		
Hajji, M., see Ben Jaballah, A. Hakola, A., O. Heczko, A. Jaakkola, T. Kajava and K. Ullakko, Ni–Mn–Ga films on Si, GaAs and Ni–Mn–Ga single crystals by pulsed laser deposition Haron, S., see Nabok, A. Heckl, W.M., see Drobek, T. Herczko, O., see Hakola, A. Herrera-Perez, J.L., see Diaz-Reyes, J. Heun, S., see Aballe, L. Hino, T., T. Taguchi, Y. Yamauchi, Y. Hirohata and M. Nishikawa, Morphological change of polycrystalline copper after ion irradiation followed by annealing Hajji, M., see Ben Jaballah, A. 238 (2004) 199 Kaneko, K., see Miao, L. Khaydar, A.M., see Kovalyova, L.A. Khayet, M., Membrane surface modification and characterization by X-ray photoelectron spectroscopy, atomic force microscopy and contact angle measurements 238 (2004) 269 Kim, J.H., see Yoon, TY. 238 (2004) 299 Kim, M.W., see Yoon, TY. 238 (2004) 299 Kinnomura, A., see Tsubakino, H. 238 (2004) 464 Kiricsi, I., see Ötvös, Zs. 238 (2004) 138 Klein, N., see Vitusevich, S.A. 238 (2004) 138 Klein, N., see Vitusevich, S.A. 238 (2004) 143 Kluska, S., see Stapinski, T. 238 (2004) 143 Koide, S., see Tanemura, S. 238 (2004) 189 Koinuma, H., see Yamamoto, Y. 238 (2004) 125				
Hakola, A., O. Heczko, A. Jaakkola, T. Kajava and K. Ullakko, Ni–Mn–Ga films on Si, GaAs and Ni–Mn–Ga single crystals by pulsed laser deposition Haron, S., see Nabok, A. Heckl, W.M., see Drobek, T. Heczko, O., see Hakola, A. Herrera-Perez, J.L., see Diaz-Reyes, J. Heun, S., see Aballe, L. Hino, T., T. Taguchi, Y. Yamauchi, Y. Hirohata and M. Nishikawa, Morphological change of polycrystalline copper after ion irradiation followed by annealing Hakola, A., O. Heczko, A. Jaakkola, T. Kajava and K. Ullakko, Ni–Mn–Ga films on Si, Khayet, M., Membrane surface modification and characterization by X-ray photoelectron spectroscopy, atomic force microscopy and contact angle measurements 238 (2004) 269 Kim, J.H., see Yoon, TY. 238 (2004) 299 Kinomura, A., see Tsubakino, H. 238 (2004) 464 Kiricsi, I., see Ötvös, Zs. 238 (2004) 138 Kiskinova, M., see Aballe, L. 238 (2004) 138 Kiskinova, M., see Aballe, L. 238 (2004) 138 Kiluska, S., see Stapinski, T. 238 (2004) 367 Kluska, S., see Tanemura, S. 238 (2004) 189 Horino, Y., see Hino, T. 238 (2004) 444 Koide, S., see Tanemura, S. 238 (2004) 189 Kondo, Y., see Miao, L. 238 (2004) 125	Haiji M see Ben Jahallah A	238 (2004) 199		
and K. Ullakko, Ni–Mn–Ga films on Si, GaAs and Ni–Mn–Ga single crystals by pulsed laser deposition Haron, S., see Nabok, A. 238 (2004) 423 Heckl, W.M., see Drobek, T. Heczko, O., see Hakola, A. Herrera-Perez, J.L., see Diaz-Reyes, J. Heun, S., see Aballe, L. Hino, T., T. Taguchi, Y. Yamauchi, Y. Hirohata and M. Nishikawa, Morphological change of polycrystalline copper after ion irradiation followed by annealing Amount of the polycrystalline copper after ion irradiation followed by annealing Herrino, Y., see Tsubakino, H. 238 (2004) 444 Horino, Y., see Tsubakino, H. 238 (2004) 444 Kiricsi, I., see Otvös, Zs. Kiein, N., see Vitusevich, S.A. Kiein, N., see Vitusevich, S.A. Kiluska, S., see Stapinski, T. 238 (2004) 360 Koide, S., see Tanemura, S. Koinuma, H., see Yamamoto, Y. 238 (2004) 125	**	230 (2004) 133		
GaAs and Ni-Mn-Ga single crystals by pulsed laser deposition 238 (2004) 155 and characterization by X-ray photoelectron spectroscopy, atomic force microscopy Haron, S., see Nabok, A. 238 (2004) 423 and contact angle measurements 238 (2004) 269 Heckl, W.M., see Drobek, T. 238 (2004) 3 Kim, J.H., see Yoon, TY. 238 (2004) 299 Heczko, O., see Hakola, A. 238 (2004) 155 Kim, M.W., see Yoon, TY. 238 (2004) 299 Herrera-Perez, J.L., see Diaz-Reyes, J. 238 (2004) 400 Kinomura, A., see Tsubakino, H. 238 (2004) 464 Heun, S., see Aballe, L. 238 (2004) 138 Kiricsi, I., see Ötvös, Zs. 238 (2004) 73 Hino, T., T. Taguchi, Y. Yamauchi, Y. Hirohata and M. Nishikawa, Morphological change of polycrystalline copper after ion irradiation followed by annealing Klein, N., see Vitusevich, S.A. 238 (2004) 143 Kluska, S., see Stapinski, T. 238 (2004) 367 Kluska, S., see Tanemura, S. 238 (2004) 360 Hirohata, Y., see Hino, T. 238 (2004) 444 Koinuma, H., see Yamamoto, Y. 238 (2004) 189 Horino, Y., see Tsubakino, H. 238 (2004) 464 Kondo, Y., see Miao, L. 238 (2004) 125			*	230 (2004) 473
pulsed laser deposition 238 (2004) 155 tron spectroscopy, atomic force microscopy Haron, S., see Nabok, A. 238 (2004) 423 and contact angle measurements 238 (2004) 269 Heckl, W.M., see Drobek, T. 238 (2004) 3 Kim, J.H., see Yoon, TY. 238 (2004) 299 Heczko, O., see Hakola, A. 238 (2004) 155 Kim, M.W., see Yoon, TY. 238 (2004) 299 Herrera-Perez, J.L., see Diaz-Reyes, J. 238 (2004) 400 Kinomura, A., see Tsubakino, H. 238 (2004) 464 Heun, S., see Aballe, L. 238 (2004) 138 Kiricsi, I., see Ötvös, Zs. 238 (2004) 73 Hino, T., T. Taguchi, Y. Yamauchi, Y. Hirohata and M. Nishikawa, Morphological change of polycrystalline copper after ion irradiation followed by annealing Klein, N., see Vitusevich, S.A. 238 (2004) 143 Kluska, S., see Stapinski, T. 238 (2004) 367 Koide, S., see Tanemura, S. 238 (2004) 360 Hirohata, Y., see Hino, T. 238 (2004) 444 Koinuma, H., see Yamamoto, Y. 238 (2004) 189 Horino, Y., see Tsubakino, H. 238 (2004) 464 Kondo, Y., see Miao, L. 238 (2004) 125				
Haron, S., see Nabok, A. 238 (2004) 423 And contact angle measurements 238 (2004) 269 Heckl, W.M., see Drobek, T. Heczko, O., see Hakola, A. 238 (2004) 155 Herrera-Perez, J.L., see Diaz-Reyes, J. Heun, S., see Aballe, L. 238 (2004) 400 Heun, S., see Aballe, L. 238 (2004) 400 Hino, T., T. Taguchi, Y. Yamauchi, Y. Hirohata And M. Nishikawa, Morphological change of polycrystalline copper after ion irradiation followed by annealing 238 (2004) 444 Horino, Y., see Hino, T. 238 (2004) 444 Horino, Y., see Tsubakino, H. 238 (2004) 464 Horino, Y., see Miao, L. 238 (2004) 125		238 (2004) 155		
Heckl, W.M., see Drobek, T. 238 (2004) 3 Kim, J.H., see Yoon, TY. 238 (2004) 299 Heczko, O., see Hakola, A. 238 (2004) 155 Kim, M.W., see Yoon, TY. 238 (2004) 299 Herrera-Perez, J.L., see Diaz-Reyes, J. 238 (2004) 400 Kinomura, A., see Tsubakino, H. 238 (2004) 464 Heun, S., see Aballe, L. 238 (2004) 138 Kiricsi, I., see Ötvös, Zs. 238 (2004) 73 Hino, T., T. Taguchi, Y. Yamauchi, Y. Hirohata and M. Nishikawa, Morphological change of polycrystalline copper after ion irradiation followed by annealing Klein, N., see Vitusevich, S.A. 238 (2004) 138 Kluska, S., see Stapinski, T. 238 (2004) 367 Kluska, S., see Tanemura, S. 238 (2004) 360 Hirohata, Y., see Hino, T. 238 (2004) 444 Koinuma, H., see Yamamoto, Y. 238 (2004) 189 Horino, Y., see Tsubakino, H. 238 (2004) 464 Kondo, Y., see Miao, L. 238 (2004) 125	•			238 (2004) 269
Heczko, O., see Hakola, A. 238 (2004) 155 Kim, M.W., see Yoon, TY. 238 (2004) 299 Herrera-Perez, J.L., see Diaz-Reyes, J. 238 (2004) 400 Kinomura, A., see Tsubakino, H. 238 (2004) 464 Heun, S., see Aballe, L. 238 (2004) 138 Kiricsi, I., see Ötvös, Zs. 238 (2004) 73 Hino, T., T. Taguchi, Y. Yamauchi, Y. Hirohata and M. Nishikawa, Morphological change of polycrystalline copper after ion irradiation followed by annealing Klein, N., see Vitusevich, S.A. 238 (2004) 143 Kluska, S., see Stapinski, T. 238 (2004) 367 Koide, S., see Tanemura, S. 238 (2004) 360 Hirohata, Y., see Hino, T. 238 (2004) 444 Koinuma, H., see Yamamoto, Y. 238 (2004) 189 Horino, Y., see Tsubakino, H. 238 (2004) 464 Kondo, Y., see Miao, L. 238 (2004) 125				
Herrera-Perez, J.L., see Diaz-Reyes, J. 238 (2004) 400 Kinomura, A., see Tsubakino, H. 238 (2004) 464 Heun, S., see Aballe, L. 238 (2004) 138 Kiricsi, I., see Ötvös, Zs. 238 (2004) 73 Hino, T., T. Taguchi, Y. Yamauchi, Y. Hirohata and M. Nishikawa, Morphological change of polycrystalline copper after ion irradiation followed by annealing 238 (2004) 444 Koide, S., see Stapinski, T. 238 (2004) 367 Hirohata, Y., see Hino, T. 238 (2004) 444 Koinuma, H., see Yamamoto, Y. 238 (2004) 189 Horino, Y., see Tsubakino, H. 238 (2004) 464 Kondo, Y., see Miao, L. 238 (2004) 125				
Heun, S., see Aballe, L. 238 (2004) 138 Kiricsi, I., see Ötvös, Zs. 238 (2004) 73 Hino, T., T. Taguchi, Y. Yamauchi, Y. Hirohata and M. Nishikawa, Morphological change of polycrystalline copper after ion irradiation followed by annealing Klein, N., see Vitusevich, S.A. 238 (2004) 143 Kluska, S., see Stapinski, T. 238 (2004) 367 Koide, S., see Tanemura, S. 238 (2004) 360 Hirohata, Y., see Hino, T. 238 (2004) 444 Koinuma, H., see Yamamoto, Y. 238 (2004) 189 Horino, Y., see Tsubakino, H. 238 (2004) 464 Kondo, Y., see Miao, L. 238 (2004) 125				
Hino, T., T. Taguchi, Y. Yamauchi, Y. Hirohata and M. Nishikawa, Morphological change of polycrystalline copper after ion irradiation followed by annealing Kiskinova, M., see Aballe, L. 238 (2004) 138 Klein, N., see Vitusevich, S.A. 238 (2004) 143 Kluska, S., see Stapinski, T. 238 (2004) 367 Koide, S., see Tanemura, S. 238 (2004) 360 Hirohata, Y., see Hino, T. 238 (2004) 444 Koinuma, H., see Yamamoto, Y. 238 (2004) 189 Horino, Y., see Tsubakino, H. 238 (2004) 464 Kondo, Y., see Miao, L. 238 (2004) 125				
and M. Nishikawa, Morphological change of polycrystalline copper after ion irradiation followed by annealing 238 (2004) 444 Koide, S., see Stapinski, T. 238 (2004) 360 Hirohata, Y., see Hino, T. 238 (2004) 444 Koinuma, H., see Yamamoto, Y. 238 (2004) 189 Horino, Y., see Tsubakino, H. 238 (2004) 464 Kondo, Y., see Miao, L. 238 (2004) 125				
of polycrystalline copper after ion irradiation followed by annealing 238 (2004) 444 Hirohata, Y., see Hino, T. 238 (2004) 444 Koide, S., see Stapinski, T. 238 (2004) 360 Koide, S., see Tanemura, S. 238 (2004) 360 Koide, S., see Tanemura, S. 238 (2004) 189 Horino, Y., see Tsubakino, H. 238 (2004) 464 Kondo, Y., see Miao, L. 238 (2004) 125				
tion followed by annealing 238 (2004) 444 Koide, S., see Tanemura, S. 238 (2004) 360 Hirohata, Y., see Hino, T. 238 (2004) 444 Koinuma, H., see Yamamoto, Y. 238 (2004) 189 Horino, Y., see Tsubakino, H. 238 (2004) 464 Kondo, Y., see Miao, L. 238 (2004) 125				
Hirohata, Y., see Hino, T. 238 (2004) 444 Koinuma, H., see Yamamoto, Y. 238 (2004) 189 Kondo, Y., see Miao, L. 238 (2004) 125		238 (2004) 444		
Horino, Y., see Tsubakino, H. 238 (2004) 464 Kondo, Y., see Miao, L. 238 (2004) 125				
			and the second s	

Kotaki, H., see Tsuji, H.	238 (2004) 132	Locatelli, A., see Aballe, L.	238 (2004) 138
Kotomin, E.A., see Evarestov, R.A.	238 (2004) 457	López-López, M., see Zamora-Peredo, L.	238 (2004) 204
Kovalyova, L.A., and A.M. Khaydar, Physical		Lucero Gomez-Herrera, M., see Cardona-Bed-	****
and rheological properties of petroleum		oya, J.A.	238 (2004) 147
fluids under the radio-frequency electro-		Lui, A., see Iacob, E.	238 (2004) 24
magnetic field effect and perspectives of		Luján Ferreira, M., see Laura Foresti, M.	238 (2004) 86
technological solutions	238 (2004) 475		
Kowalczyk, Z., see Guraya, M.	238 (2004) 77	Macías-García, A., see Díaz-Díez, M.A.	238 (2004) 309
Kozhuharova, R., M. Ritschel, D. Elefant,		Macías-García, A., see Gañan, J.	238 (2004) 347
A. Graff, A. Leonhardt, I. Mönch, T. Mühl,		Macek, A., see Dian, J.	238 (2004) 169
S. Groudeva-Zotova and C.M. Schneider,		Maier, J., see Evarestov, R.A.	238 (2004) 457
Well-aligned Co-filled carbon nanotubes:		Mancic, L., see Del Rosario, G.	238 (2004) 469
preparation and magnetic properties	238 (2004) 355	Mandracci, P., S. Ferrero, S. Porro, C. Ric-	()
Kreiter, M., see Wilms, M.	238 (2004) 490	ciardi, G. Richieri and L. Scaltrito,	
Kurata, H., see Takajo, D.	238 (2004) 295	Plasma-assisted SiC oxidation for power	
Kwei, C.M., and Y.C. Li, Electron inelastic		device fabrication	238 (2004) 336
mean free paths and surface excitation para-		Mandracci, P., see Ricciardi, C.	238 (2004) 331
meters for GaAs	238 (2004) 151	Marcos, M., see Bethencourt, M.	238 (2004) 278
Labajos-Broncano, L., see Méndez-Vilas, A.	238 (2004) 42	Márquez, A.M., and J.F. Sanz, Adsorption of Pd	200 (200) 210
	238 (2004) 42	atoms on γ -Al ₂ O ₃ : a density functional	
Lamaze, G.P., H.H. Chen-Mayer and K.K.		study of metal–support interactions	238 (2004) 82
Soni, Analyses of thin films and surfaces	220 (2004) 100	Martinez-Antón, J.C., J.A. Quiroga, R. Gonzá-	230 (2004) 02
by cold neutron depth profiling	238 (2004) 108	lez-Moreno and E. Bernabeu, Optical char-	
Larena, A., and D.A. Cáceres, Variability		acterization of surfaces by robust	
between chitosan membrane surface char-		reflectance determination based on air-	
acteristics as function of its composition	220 (2004) 272	gap interference	238 (2004) 380
and environmental conditions	238 (2004) 273	Martinez-Anton, J.C., see Siegmann, P.	238 (2004) 375
Larena, A., and Jimenez de Ochoa S., Use of		Martín-Aranda, R.M., see Durán-Valle, C.J.	238 (2004) 573
different surface analysis techniques for the			238 (2004) 97
study of the photo-degradation of a poly-	220 (2004) 520	Matsumoto, T., see Tsuji, H. Matsumoto, Y., see Yamamoto, Y.	238 (2004) 132
meric matrix composite	238 (2004) 530		238 (2004) 189
Larena, A., D.A. Cáceres, C. Vicario and A.		Mazaki, Y., see Takajo, D.	
Fuentes, Release of a chitosan-hydroxya-		Mendes Ribeiro, R., see Vila Verde, A.	238 (2004) 410
patite composite loaded with ibuprofen and		Mendes Ribeiro, R., see Ramos, M.M.D.	238 (2004) 438
acetyl-salicylic acid submitted to different	220 /200 / 740	Mendes, J.A., see Almeida, B.G. Méndez-García, V.H., see Zamora-Peredo, L.	238 (2004) 395
sterilization treatments	238 (2004) 518		238 (2004) 204
Lastras-Martínez, A., see Zamora-Peredo, L.	238 (2004) 204	Méndez-Vilas, A., and M.L. González-Martín,	229 (2004) 1
Laura Foresti, M., and Luján Ferreira M., Etha-		Preface	238 (2004) 1
nol pretreatment effect and particle diameter		Méndez-Vilas, A., A.M. Gallardo-Moreno, M.L. González-Martín, R. Calzado-Mon-	
issues on the adsorption of Candida rugosa	****		
lipase onto polypropylene powder	238 (2004) 86	tero, M.J. Nuevo, J.M. Bruque and C. Pérez-Giraldo, Surface characterisation	
Laviano, F., see Chiodoni, A.	238 (2004) 485	•	
Lazzari, R., see Leroy, F.	238 (2004) 233	of two strains of Staphylococcus epidermi-	
Lee, SD., see Yoon, TY.	238 (2004) 299	dis with different slime-production by	220 (2004) 10
Lee, SD., see Yu, CJ.	238 (2004) 385	AFM	238 (2004) 18
Lee, SL., see Chaudhari, A.	238 (2004) 513	Méndez-Vilas, A., I. Corbacho, M.L. González-	
Leonhardt, A., see Kozhuharova, R.	238 (2004) 355	Martín and M.J. Nuevo, Direct surface	
Leroy, F., C. Revenant, G. Renaud and R.		probing of cell wall-defective mutants of	
Lazzari, In situ GISAXS study of the		Saccharomyces cerevisiae by atomic force	220 (2004) 51
growth of Pd on MgO(0 0 1)	238 (2004) 233	microscopy	238 (2004) 51
Levinshtein, M., see Goldfarb, I.	238 (2004) 29	Méndez-Vilas, A., M.L. González-Martín and	
Li, Y.C., see Kwei, C.M.	238 (2004) 151	M.J. Nuevo, Some geometrical considera-	
Li, Y.J., R. Tero, T. Nagasawa, T. Nagata and		tions about the influence of topography on	
T. Urisu, Deposition of 10-undecenoic acid		the adhesion force as measured by AFM on	220 (2004)
self-assembled layers on H-Si(1 1 1) sur-		curved surfaces	238 (2004) 9
faces studied with AFM and FT-IR	238 (2004) 238	Méndez-Vilas, A., M.L. González-Martín, L.	
Li, Y.J., see Tero, R.	238 (2004) 218	Labajos-Broncano and M.J. Nuevo, Arti-	
Lin, CC., SY. Chen and SY. Cheng, Phy-		facts in AFM images revealed using friction	220 (2004) 12
sical characteristics and photoluminescence		maps	238 (2004) 42
properties of phosphorous-implanted ZnO		Mendoza-Alvarez, J.G., see Cardona-Bedoya,	000 (000 1) 1 17
thin films	238 (2004) 405	J.A.	238 (2004) 147

Mendoza-Alvarez, J.G., see Diaz-Reyes, J.	238 (2004) 400	Ocaña, J.L., C. Molpeceres, J.A. Porro, G.	
Meotto, U.M., see Ricciardi, C.	238 (2004) 331	Gómez and M. Morales, Experimental	
Mezzetti, E., see Chiodoni, A.	238 (2004) 485	assessment of the influence of irradiation	
Miao, L., S. Tanemura, S. Toh, K. Kaneko		parameters on surface deformation and resi-	
and M. Tanemura, Heating-sol-gel		dual stresses in laser shock processed	
template process for the growth of		metallic alloys	238 (2004) 501
TiO ₂ nanorods with rutile and anatase struc-		Ocaña, J.L., M. Morales, C. Molpeceres and J.	
ture	238 (2004) 175	Torres, Numerical simulation of surface	
Miao, L., S. Tanemura, Y. Kondo, M. Iwata, S.		deformation and residual stresses fields in	
Toh and K. Kaneko, Microstructure and		laser shock processing experiments	238 (2004) 242
bactericidal ability of photocatalytic TiO2		Ohara, S., see Del Rosario, G.	238 (2004) 469
thin films prepared by rf helicon magnetron		Oikawa, D., see Sekine, Y.	238 (2004) 14
sputtering	238 (2004) 125	Okazaki, S., see Afrin, R.	238 (2004) 47
Miao, L., see Tanemura, S.	238 (2004) 360	Onyestyák, Gy., see Ötvös, Zs.	238 (2004) 73
Migliaresi, C., see Tessarolo, F.	238 (2004) 341	Osendi, M.I., see Polanco, R.	238 (2004) 506
Milosevic, O., see Del Rosario, G.	238 (2004) 469	Otero Areán, C., see Storozhev, P.Yu.	238 (2004) 390
Minetti, B., see Chiodoni, A.	238 (2004) 485	Ötvös, Zs., Gy. Onyestyák, J. Valyon, I. Kiricsi,	
Miranzo, P., see Polanco, R.	238 (2004) 506	Z. Kónya and L.V.C. Rees, The dynamics of	
Mitamura, T., see Tsubakino, H.	238 (2004) 464	H_2 and N_2 sorption in carbon nanotubes	238 (2004) 73
Miyamoto, I., see Taniguchi, J.	238 (2004) 324	Ozaki, H., see Takajo, D.	238 (2004) 282
Miyazawa, T., see Taniguchi, J.	238 (2004) 324		
Molpeceres, C., see Ocaña, J.L.	238 (2004) 242	Park, JH., see Yu, CJ.	238 (2004) 385
Molpeceres, C., see Ocaña, J.L.	238 (2004) 501	Parra, J.B., C.O. Ania, A. Arenillas, F. Rubiera	
Mönch, I., see Kozhuharova, R.	238 (2004) 355	and J.J. Pis, High value carbon materials	
Montanero, J.M., see Cabezas, M.G.	238 (2004) 480	from PET recycling	238 (2004) 304
Monte, A.F.G., see Dantas, N.O.	238 (2004) 209	Patelli, A., J. Ravagnan, V. Rigato, G. Salmaso,	
Morais, P.C., see Dantas, N.O.	238 (2004) 209	D. Silvestrini, E. Bontempi and L.E.	
Morales, M., see Ocaña, J.L.	238 (2004) 242	Depero, Structure and interface properties	
Morales, M., see Ocaña, J.L.	238 (2004) 501	of Mo/B ₄ C/Si multilayers deposited by rf-	
Mori, Y., see Tanemura, S.	238 (2004) 360	magnetron sputtering	238 (2004) 262
Motta, A., see Tessarolo, F.	238 (2004) 341	Pérez-Giraldo, C., see Méndez-Vilas, A.	238 (2004) 18
Mühl, T., see Kozhuharova, R.	238 (2004) 355	Perez-Martin, A.M.C., see Said-Ettaoussi, M.	238 (2004) 249
Muhler, M., see Guraya, M.	238 (2004) 77	Pérez-Martín, A.M.C., see Jiménez-Sáez, J.C.	238 (2004) 223
Murakami, S., see Nomura, H.	238 (2004) 113	Perrard, A., see Gaillard, F.	238 (2004) 91
		Perruchot, C., see Baeta Neves, I.	238 (2004) 523
Nabatova-Gabain, N., see Tanemura, S.	238 (2004) 360	Pesquera, C., F. González, C. Blanco and L.	
Nabok, A., S. Haron and A. Ray, Registration		Sanchez, Synthesis and characterization of	
of heavy metal ions and pesticides		lanthanum incorporated mesoporous mole-	
with ATR planar waveguide enzyme sen-		cular sieves	238 (2004) 320
sors	238 (2004) 423	Petrychuk, M.V., see Vitusevich, S.A.	238 (2004) 143
Nagasawa, T., see Li, Y.J.	238 (2004) 238	Pietka, A., see Almeida, B.G.	238 (2004) 395
Nagata, T., see Li, Y.J.	238 (2004) 238	Pirri, C.F., see Chiodoni, A.	238 (2004) 485
Nefedov, A.A., see Speranza, G.	238 (2004) 117	Pis, J.J., see Parra, J.B.	238 (2004) 304
Němec, I., see Dian, J.	238 (2004) 169	Polanco, R., A. De Pablos, P. Miranzo and M.I.	
Nemoto, T., see Takajo, D.	238 (2004) 282	Osendi, Metal-ceramic interfaces: joining	220 (2004) 506
Nemoto, T., see Takajo, D.	238 (2004) 295	silicon nitride-stainless steel	238 (2004) 506
Neumann, A.W., see Cabezas, M.G.	238 (2004) 480	Porro, J.A., see Ocaña, J.L.	238 (2004) 501
Nishikawa, M., see Hino, T.	238 (2004) 444	Porro, S., see Mandracci, P.	238 (2004) 336
Nishio, S., see Ito, Y.	238 (2004) 159	0 F D NO	220 (2004) 200
Nižňanský, D., see Dian, J.	238 (2004) 169	Qu, F., see Dantas, N.O.	238 (2004) 209
Nogami, A., see Tsubakino, H.	238 (2004) 464	Quiroga, J.A., see Martinez-Antón, J.C.	238 (2004) 380
Nollo, G., see Tessarolo, F.	238 (2004) 341	n	
Nomura, H., S. Murakami, A. Ide-Ektessabi,		Ramos, M.M.D., A.M. Almeida, H.M.G. Cor-	
Y. Tanaka and Y. Tsukuda, Ion beam pro-		reia, Mendes Ribeiro R. and A.M. Stone-	
cessing of magnesium oxide thin films for	000 (000 t) 115	ham, Effect of molecular properties on the	
PDP application	238 (2004) 113	performance of polymer light-emitting	220 (2004) 120
Nuevo, M.J., see Méndez-Vilas, A.	238 (2004) 9	diodes	238 (2004) 438
Nuevo, M.J., see Méndez-Vilas, A.	238 (2004) 18	Ramos, M.M.D., see Vila Verde, A.	238 (2004) 410
Nuevo, M.J., see Méndez-Vilas, A.	238 (2004) 42	Ramírez-Flores, G., see Zamora-Peredo, L.	238 (2004) 204
Nuevo, M.J., see Méndez-Vilas, A.	238 (2004) 51	Rarog-Pilecka, W., see Guraya, M.	238 (2004) 77

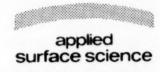
Author Index

Rath, C., see Farjas, J.	238 (2004) 165	Silva, R.S., see Dantas, N.O.	238 (2004) 209
Ravagnan, J., see Patelli, A.	238 (2004) 262	Silvestrini, D., see Patelli, A.	238 (2004) 262
Ray, A., see Nabok, A.	238 (2004) 423	Silvia, B., see Tessarolo, F.	238 (2004) 341
Rees, L.V.C., see Ötvös, Zs.	238 (2004) 73	Skladnik-Sadowska, E., see Sadowski, M.J.	238 (2004) 433
Reiter, M., see Drobek, T.	238 (2004) 73	Sleptsov, V.V., see Speranza, G.	238 (2004) 117
Renaud, G., see Leroy, F.	238 (2004) 233	Soni, K.K., see Lamaze, G.P.	238 (2004) 117
Revenant, C., see Leroy, F.	238 (2004) 233	Speranza, G., L. Calliari, M. Ferrari, A. Chia-	238 (2004) 108
Ricciardi, C., See Leroy, F. Ricciardi, C., E. Aimo Boot, F. Giorgis, P.	236 (2004) 233	sera, K. Tran Ngoc, A.M. Baranov, V.V.	
Mandracci, U.M. Meotto and G. Barucca,		Sleptsov, A.A. Nefedov, A.E. Varfolomeev	
Polycrystalline SiC growth and character-		and S.S. Fanchenko, Erbium-doped thin	
ization	238 (2004) 331	amorphous carbon films prepared by mixed	
Ricciardi, C., see Mandracci, P.	238 (2004) 331	CVD sputtering	238 (2004) 117
Richieri, G., see Mandracci, P.	238 (2004) 336	Sprenger, S., see Guraya, M.	238 (2004) 77
			236 (2004) 11
Rigato, V., see Patelli, A.	238 (2004) 262	Stankiewicz, B., W. Kamiński and L. Jurczys-	
Rigo, A., see Tessarolo, F.	238 (2004) 341	zyn, Missing dimer defect on β -SiC(0 0 1)-	
Ritschel, M., see Kozhuharova, R.	238 (2004) 355	$c(2 \times 2)$ surface—numerical analysis of the	229 (2004) 26
Rivera, Z., see Zamora-Peredo, L.	238 (2004) 204	structure and STM profiles	238 (2004) 36
Roca i Cabarrocas, P., see Farjas, J.	238 (2004) 165	Stapinski, T., B. Swatowska, S. Kluska and E.	
Rodríguez Delgado, M., see Storozhev, P.Yu.	238 (2004) 390	Walasek, Optical and structural properties	
Rodríguez-Vázquez, A.G., see Zamora-Peredo,	228 (2004) 204	of amorphous silicon-carbon films for	228 (2004) 267
L.	238 (2004) 204	optoelectronic applications	238 (2004) 367
Roura, P., see Farjas, J.	238 (2004) 165	Stoch, A., see Surowska, B.	238 (2004) 288
Rubiera, F., see Parra, J.B.	238 (2004) 304	Stoneham, A.M., see Ramos, M.M.D.	238 (2004) 438
0 1 1 1 0	220 (2004) 102	Stoneham, M., see Vila Verde, A.	238 (2004) 410
Saadoun, M., see Aouida, S.	238 (2004) 193	Storozhev, P.Yu., V.S. Yanko, A.A. Tsyga-	
Saadoun, M., see Ben Jaballah, A.	238 (2004) 199	nenko, G. Turnes Palomino, M. Rodríguez	
Sabio, E., see Gañan, J.	238 (2004) 347	Delgado and C. Otero Areán, Isomeric	
Sadowski, M.J., J. Baranowski, E. Skladnik-		states of polar molecules on ionic surfaces:	****
Sadowska, V.N. Borisko, O.V. Byrka, V.I.		electrostatic model and FTIR studies	238 (2004) 390
Tereshin and A.V. Tsarenko, Characteriza-		Surowska, B., J. Bieniaś, M. Walczak, K. Sang-	
tion of pulsed plasma-ion streams emitted		wal and A. Stoch, Microstructure and	
from RPI-type devices applied for material	220 (2004) 422	mechanical properties of ceramic coatings	****
engineering	238 (2004) 433	on Ti and Ti-based alloy	238 (2004) 288
Said-Ettaoussi, M., J.C. Jimenez-Saez, A.M.C.		Swatowska, B., see Stapinski, T.	238 (2004) 367
Perez-Martin and J.J. Jimenez-Rodriguez,		Szmigiel, D., see Guraya, M.	238 (2004) 77
Deformation behaviour induced by point	****		***
defects near a Cu(0 0 1) surface	238 (2004) 249	Taguchi, T., see Hino, T.	238 (2004) 444
Salmaso, G., see Patelli, A.	238 (2004) 262	Takajo, D., T. Nemoto, H. Kurata and S. Isoda,	
Sanchez, L., see Pesquera, C.	238 (2004) 320	Molecular-scale structure fabrication at	
Sanchez-Brea, L.M., see Siegmann, P.	238 (2004) 375	liquid/solid interfaces	238 (2004) 295
Sanders Yan, CC., see Chaudhari, A.	238 (2004) 513	Takajo, D., T. Nemoto, H. Ozaki, Y. Mazaki and	
Sangwal, K., see Surowska, B.	238 (2004) 288	S. Isoda, Organization of copper-phthalo-	
Sanz, J.F., see Márquez, A.M.	238 (2004) 82	cyanine molecules on mono-molecular	
Sanz, J.F., see Cruz Hernández, N.	238 (2004) 228	organic buffer layers	238 (2004) 282
Sasase, M., see Ito, Y.	238 (2004) 159	Takizawa, M., see Tero, R.	238 (2004) 218
Scaltrito, L., see Mandracci, P.	238 (2004) 336	Tallarida, G., see Chiodoni, A.	238 (2004) 485
Schneider, C.M., see Kozhuharova, R.	238 (2004) 355	Tanaka, Y., see Nomura, H.	238 (2004) 113
Sekine, Y., D. Oikawa and M. Butsugan, Deter-		Tanemura, M., see Miao, L.	238 (2004) 175
mination of uptake rate of sensitive diffu-		Tanemura, S., L. Miao, S. Koide, Y. Mori, P. Jin,	
sion sampler for formaldehyde in air	238 (2004) 14	A. Terai and N. Nabatova-Gabain, Optical	
Shinoda, K., see Taniguchi, J.	238 (2004) 324	properties of metal and semiconductor SmS	
Siegmann, P., L.M. Sanchez-Brea, J.C. Marti-		thin films fabricated by rf/dc dual magne-	
nez-Anton and E. Bernabeu, Comparison		tron sputtering	238 (2004) 360
between optical techniques and confocal		Tanemura, S., see Miao, L.	238 (2004) 125
microscopy for defect detection on thin		Tanemura, S., see Miao, L.	238 (2004) 175
wires	238 (2004) 375	Taniguchi, J., M. Iida, T. Miyazawa, I. Miya-	
Silva, G.G., P.M. de Freitas Rocha, P.S. de		moto and K. Shinoda, 3D imprint technol-	
Oliveira and B.R. Almeida Neves, Domain		ogy using substrate voltage change	238 (2004) 324
size effects on the thermal properties of PS/		Tannenbaum, R., see Greene, G.	238 (2004) 101
PMMA blends	238 (2004) 64	Terai, A., see Tanemura, S.	238 (2004) 360

Terasawa, M., see Tsubakino, H.	238 (2004) 464	Vasilev, K., see Wilms, M.	238 (2004) 490
Tereshin, V.I., see Sadowski, M.J.	238 (2004) 433	Vicari, L., see Bloisi, F.	238 (2004) 121
Tero, R., M. Takizawa, Y.J. Li, M. Yamazaki		Vicario, C., see Larena, A.	238 (2004) 518
and T. Urisu, Deposition of phospholipid		Vicente, F., see García-Jareño, J.J.	238 (2004) 449
layers on SiO ₂ surface modified by alkyl-		Vila Verde, A., M.M.D. Ramos, M. Stoneham	
SAM islands	238 (2004) 218	and R. Mendes Ribeiro, Mesoscopic mod-	
Tero, R., see Li, Y.J.	238 (2004) 238	elling of the interaction of infrared lasers	
Tessarolo, F., P. Ferrari, B. Silvia, A. Motta, C.		with composite materials: an application to	
Migliaresi, L. Zennaro, A. Rigo, G.M.		human dental enamel	238 (2004) 410
Guarrera and G. Nollo, Evaluation and		Vitusevich, S.A., S.V. Danylyuk, M.V. Petry-	
quantification of reprocessing modification		chuk, O.A. Antoniuk, N. Klein and A.E.	
in single-use devices in interventional car-		Belyaev, Equilibrium and non-equilibrium	
diology	238 (2004) 341	1/f noise in AlGaN/GaN TLM structures	238 (2004) 143
Toh, S., see Miao, L.	238 (2004) 125	Vrkoslav, V., see Dian, J.	238 (2004) 169
Toh, S., see Miao, L.	238 (2004) 175		
Torres, J., see Ocaña, J.L.	238 (2004) 242	Walasek, E., see Stapinski, T.	238 (2004) 367
Tran Ngoc, K., see Speranza, G.	238 (2004) 117	Walczak, M., see Surowska, B.	238 (2004) 288
Tresso, E., see Chiodoni, A.	238 (2004) 485	Wegner, G., see Wilms, M.	238 (2004) 490
Triki, M., and S. Jaziri, Polaronic states in II-VI		Wilms, M., J. Conrad, K. Vasilev, M. Kreiter	
quantum dot	238 (2004) 213	and G. Wegner, Manipulation and conduc-	
Tsarenko, A.V., see Sadowski, M.J.	238 (2004) 433	tivity measurements of gold nanowires	238 (2004) 490
Tsubakino, H., A. Nogami, Y. Yamamoto, A.		•	
Yamamoto, M. Terasawa, T. Mitamura, A.		Yamamoto, A., see Ito, Y.	238 (2004) 159
Kinomura and Y. Horino, Surface segrega-		Yamamoto, A., see Tsubakino, H.	238 (2004) 464
tion phenomena of solute elements in Al-		Yamamoto, Y., see Tsubakino, H.	238 (2004) 464
Pb and Al-Fe dilute binary alloys	238 (2004) 464	Yamamoto, Y., Y. Matsumoto and H. Koinuma,	
Tsuji, H., N. Arai, T. Matsumoto, K. Ueno, Y.		Homo-epitaxial growth of rutile TiO2 film	
Gotoh, K. Adachi, H. Kotaki and J. Ishi-		on step and terrace structured substrate	238 (2004) 189
kawa, Silver nanoparticle formation in thin		Yamauchi, T., see Ito, Y.	238 (2004) 159
oxide layer on silicon by silver-negative-ion		Yamauchi, Y., see Hino, T.	238 (2004) 444
implantation for Coulomb blockade at room		Yamazaki, M., see Tero, R.	238 (2004) 218
temperature	238 (2004) 132	Yanko, V.S., see Storozhev, P.Yu.	238 (2004) 390
Tsukuda, Y., see Nomura, H.	238 (2004) 113	Yasuda, K., see Ito, Y.	238 (2004) 159
Tsyganenko, A.A., see Storozhev, P.Yu.	238 (2004) 390	Yoon, TY., C. Jeong, J.H. Kim, M.C. Choi,	, , , , , , , , , , , , , , , , , , , ,
Turnes Palomino, G., see Storozhev, P.Yu.	238 (2004) 390	M.W. Kim and SD. Lee, Spontaneous	
,,,,,,		aggregation of lipids in supported mem-	
Ueno, K., see Tsuji, H.	238 (2004) 132	branes with geometrical barriers	238 (2004) 299
Ullakko, K., see Hakola, A.	238 (2004) 155	Yu, CJ., JH. Park and SD. Lee, Determina-	
Urisu, T., see Li, Y.J.	238 (2004) 238	tion of surface anchoring energies of liquid	
Urisu, T., see Tero, R.	238 (2004) 218	crystals by optical diffraction	238 (2004) 385
Uskokovic, D., see Ignjatovic, N.	238 (2004) 314	oryonas oy opioen cimerion	200 (200.) 000
condition, 2., see Ignjacovic, 11.	250 (2001) 511	Zamora-Peredo, L., M. López-López, Z. Riv-	
Valyon, J., see Ötvös, Zs.	238 (2004) 73	era, A. Guillén, A.G. Rodríguez-Vázquez,	
Váquez, M.I., P. Galán, J. Casado, M.J. Ariza	200 (2001)	G. Ramírez-Flores, A. Lastras-Martínez	
and J. Benavente, Effect of radiation and		and V.H. Méndez-García, Quantum Hall	
thermal treatment on structural and trans-		effect devices based on AlGaAs/GaAs	
port parameters for cellulose regenerated		structures studied by photoreflectance spec-	
membranes	238 (2004) 415	troscopy	238 (2004) 204
Varfolomeev, A.E., see Speranza, G.	238 (2004) 117	Zennaro, L., see Tessarolo, F.	238 (2004) 341
The second secon			



Applied Surface Science 238 (2004) VIII-XVI



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Subject Index

Alloys		Arsenic	
Experimental assessment of the influence of irradiation parameters on surface deformation and residual stresses in laser shock processed metallic alloys, J.L. Ocaña, C. Molpeceres, J.A. Porro, G. Gómez and M. Morales	238 (2004) 501	Study of GaN _x As _{1-x} semiconducting films grown by laser pulsed deposition on crystal-line and amorphous substrates, J.A. Cardona-Bedoya, A. Cruz-Orea, J.G. Mendoza-Alvarez, M. Lucero Gomez-Herrera, M.H. Farias and J.A. Diaz Photoluminescence studies in highly Te-doped	238 (2004) 147
Aluminium oxide		$Ga_{1-x}In_xAs_ySb_{1-y}$ epitaxial layers grown on GaSb by liquid phase epitaxy, J. Diaz-	
First principles simulations of Cu and Au deposition on α-Al ₂ O ₃ (0 0 0 1) surface, N. Cruz Hernández and J.F. Sanz	238 (2004) 228	Reyes, J.L. Herrera-Perez, M.L. Gomez- Herrera, J.A. Cardona-Bedoya and J.G. Mendoza-Alvarez	238 (2004) 400
Aluminium		Atomic force microscopy	
Surface segregation phenomena of solute ele- ments in Al-Pb and Al-Fe dilute binary alloys, H. Tsubakino, A. Nogami, Y. Yama- moto, A. Yamamoto, M. Terasawa, T. Mita- mura, A. Kinomura and Y. Horino	238 (2004) 464	Some geometrical considerations about the influence of topography on the adhesion force as measured by AFM on curved surfaces, A. Méndez-Vilas, M.L. González-Martín and M.J. Nuevo	238 (2004) 9
Ammonia The effect of promoters on the electronic struc-		Surface characterisation of two strains of Sta- phylococcus epidermidis with different slime-production by AFM, A. Méndez- Vilas, A.M. Gallardo-Moreno, M.L. Gon-	
ture of ruthenium catalysts supported on carbon, M. Guraya, S. Sprenger, W. Rarog-Pilecka, D. Szmigiel, Z. Kowalczyk and M. Muhler	238 (2004) 77	zález-Martín, R. Calzado-Montero, M.J. Nuevo, J.M. Bruque and C. Pérez-Giraldo Topography induced by sputtering in a mag- netic sector instrument: an AFM and SEM	238 (2004) 18
An intermittent temperature-programmed des- orption method for studying kinetics of desorption from heterogeneous surfaces, F. Gaillard, M. Abdat, J.P. Joly and A. Perrard	238 (2004) 91	study, E. Iacob, M. Bersani, A. Lui, D. Giubertoni, M. Barozzi and M. Anderle Artifacts in AFM images revealed using friction maps, A. Méndez-Vilas, M.L. González-Martín, L. Labajos-Broncano and M.J.	238 (2004) 24
Antimony	250 (2001) 71	Nuevo Direct surface probing of cell wall-defective mutants of Saccharomyces cerevisiae by	238 (2004) 42
Photoluminescence studies in highly Te-doped $Ga_{1-x}In_xAs_ySb_{1-y}$ epitaxial layers grown on GaSb by liquid phase epitaxy, J. Diaz-Reyes, J.L. Herrera-Perez, M.L. Gomez-		atomic force microscopy, A. Méndez-Vilas, I. Corbacho, M.L. González-Martín and M.J. Nuevo Domain size effects on the thermal properties of PS/PMMA blends, G.G. Silva, P.M. de	238 (2004) 51
Herrera, J.A. Cardona-Bedoya and J.G. Mendoza-Alvarez	238 (2004) 400	Freitas Rocha, P.S. de Oliveira and B.R. Almeida Neves	238 (2004) 64

Characterization of silicon-YBCO buffered multilayers grown by sputtering, A. Chio-		Calorimetry	
doni, V. Ballarini, D. Botta, C. Camerlingo, F. Fabbri, S. Ferrari, R. Gerbaldo, G. Ghigo, L. Gozzelino, F. Laviano, B. Minetti, C.F.		Use of different surface analysis techniques for the study of the photo-degradation of a	
Pirri, G. Tallarida, E. Tresso and E. Mezzetti	238 (2004) 485	polymeric matrix composite, A. Larena and S. Jimenez de Ochoa	238 (2004) 530
Band structures		Carbides	
First principles simulations of Cu and Au deposition on α-Al ₂ O ₃ (0 0 0 1) surface, N. Cruz Hernández and J.F. Sanz	238 (2004) 228	Structure and interface properties of Mo/B ₄ C/Si multilayers deposited by rf-magnetron sputtering, A. Patelli, J. Ravagnan, V. Rigato, G. Salmaso, D. Silvestrini, E. Bon-	
Biological materials		tempi and L.E. Depero	238 (2004) 262
Surface characterisation of two strains of Sta- phylococcus epidermidis with different slime-production by AFM, A. Méndez-		Carbon	
Vilas, A.M. Gallardo-Moreno, M.L. Gon- zález-Martín, R. Calzado-Montero, M.J. Nuevo, J.M. Bruque and C. Pérez-Giraldo Direct surface probing of cell wall-defective	238 (2004) 18	The effect of promoters on the electronic struc- ture of ruthenium catalysts supported on carbon, M. Guraya, S. Sprenger, W. Rarog-Pilecka, D. Szmigiel, Z. Kowalczyk	
mutants of Saccharomyces cerevisiae by atomic force microscopy, A. Méndez-Vilas, I. Corbacho, M.L. González-Martín and	220 (2001) 21	and M. Muhler Erbium-doped thin amorphous carbon films prepared by mixed CVD sputtering, G.	238 (2004) 77
M.J. Nuevo Mesoscopic modelling of the interaction of infrared lasers with composite materials: an application to human dental enamel,	238 (2004) 51	Speranza, L. Calliari, M. Ferrari, A. Chiasera, K. Tran Ngoc, A.M. Baranov, V.V. Sleptsov, A.A. Nefedov, A.E. Varfolomeev and S.S. Fanchenko	238 (2004) 117
A. Vila Verde, M.M.D. Ramos, M. Stone- ham and R. Mendes Ribeiro	238 (2004) 410	Optical and structural properties of amorphous silicon-carbon films for optoelectronic applications, T. Stapinski, B. Swatowska,	
Barium		S. Kluska and E. Walasek	238 (2004) 367
Characterization of silicon—YBCO buffered multilayers grown by sputtering, A. Chio- doni, V. Ballarini, D. Botta, C. Camerlingo,		Carbon monoxide	
F. Fabbri, S. Ferrari, R. Gerbaldo, G. Ghigo, L. Gozzelino, F. Laviano, B. Minetti, C.F. Pirri, G. Tallarida, E. Tresso and E. Mez- zetti	238 (2004) 485	Isomeric states of polar molecules on ionic surfaces: electrostatic model and FTIR studies, P.Yu. Storozheva, V.S. Yanko, A.A. Tsyganenko, G. Turnes Palomino, M.	200 (2004) 200
Boron		Rodríguez Delgado, C. Otero Areán	238 (2004) 390
		Catalysis	
Structure and interface properties of Mo/B ₄ C/Si multilayers deposited by rf-magnetron sputtering, A. Patelli, J. Ravagnan, V. Rigato, G. Salmaso, D. Silvestrini, E. Bontempi and L.E. Depero	238 (2004) 262	The effect of promoters on the electronic struc- ture of ruthenium catalysts supported on carbon, M. Guraya, S. Sprenger, W. Rarog-Pilecka, D. Szmigiel, Z. Kowalczyk and M. Muhler	238 (2004) 77
Calcium		und M. Manifel	250 (2004) 11
Release of a chitosan-hydroxyapatite compo-		Ceramics	
site loaded with ibuprofen and acetyl-sal- icylic acid submitted to different sterilization treatments, A. Larena, D.A. Cáceres, C. Vicario and A. Fuentes	238 (2004) 518	Metal-ceramic interfaces: joining silicon nitride-stainless steel, R. Polanco, A. De Pablos, P. Miranzo and M.I. Osendi	238 (2004) 506

Cerium		Electron diffraction	
Characterisation of YAG:Ce powders thermal treated at different temperatures, G. Del Rosario, S. Ohara, L. Mancic and O. Milosevic	238 (2004) 469	Characterisation of YAG:Ce powders thermal treated at different temperatures, G. Del Rosario, S. Ohara, L. Mancic and O. Milosevic	238 (2004) 469
Chemical vapour deposition		Electron microscopy	
Erbium-doped thin amorphous carbon films prepared by mixed CVD sputtering, G. Speranza, L. Calliari, M. Ferrari, A. Chiasera, K. Tran Ngoc, A.M. Baranov, V.V. Sleptsov, A.A. Nefedov, A.E. Varfolomeev and S.S. Fanchenko Optical and structural properties of amorphous silicon—carbon films for optoelectronic	238 (2004) 117	Ni-Mn-Ga films on Si, GaAs and Ni-Mn-Ga single crystals by pulsed laser deposition, A. Hakola, O. Heczko, A. Jaakkola, T. Kajava and K. Ullakko Surface segregation phenomena of solute elements in Al-Pb and Al-Fe dilute binary alloys, H. Tsubakino, A. Nogami, Y. Yamamoto, A. Yamamoto, M. Terasawa, T. Mitamura, A. Kinomura and Y. Horino	238 (2004) 155 238 (2004) 464
applications, T. Stapinski, B. Swatowska, S. Kluska and E. Walasek	238 (2004) 367	Characterisation of YAG:Ce powders thermal treated at different temperatures, G. Del Rosario, S. Ohara, L. Mancic and O. Milo-	220 (2004) 460
Computer simulations		sevic Metal-ceramic interfaces: joining silicon nitride-stainless steel, R. Polanco, A. De Pablos, P. Miranzo and M.I. Osendi	238 (2004) 469 238 (2004) 506
First principles simulations of Cu and Au deposition on α-Al ₂ O ₃ (0 0 0 1) surface, N. Cruz Hernández and J.F. Sanz Numerical simulation of surface deformation	238 (2004) 228	Epitaxy	230 (2004) 300
and residual stresses fields in laser shock processing experiments, J.L. Ocaña, M. Morales, C. Molpeceres and J. Torres	238 (2004) 242	Photoluminescence studies in highly Te-doped $Ga_{1-x}In_xAs_ySb_{1-y}$ epitaxial layers grown on GaSb by liquid phase epitaxy, J. Diaz-Reyes, J.L. Herrera-Perez, M.L. Gomez-Herrera, J.A. Cardona-Bedoya and J.G.	220 (2004) 400
Copper		Mendoza-Alvarez	238 (2004) 400
First principles simulations of Cu and Au deposition on α-Al ₂ O ₃ (0 0 0 1) surface,		Erbium	
N. Cruz Hernández and J.F. Sanz Deformation behaviour induced by point defects near a Cu(0 0 1) surface, M. Said-Ettaoussi, J.C. Jimenez-Saez, A.M.C. Perez-Martin and	238 (2004) 228	Erbium-doped thin amorphous carbon films prepared by mixed CVD sputtering, G. Speranza, L. Calliari, M. Ferrari, A. Chia- sera, K. Tran Ngoc, A.M. Baranov, V.V.	
J.J. Jimenez-Rodriguez Characterization of silicon-YBCO buffered multilayers grown by sputtering, A. Chiodoni, V. Ballarini, D. Botta, C. Camerlingo,	238 (2004) 249	Sleptsov, A.A. Nefedov, A.E. Varfolomeev and S.S. Fanchenko Evaporation	238 (2004) 117
F. Fabbri, S. Ferrari, R. Gerbaldo, G. Ghigo, L. Gozzelino, F. Laviano, B. Minetti, C.F. Pirri, G. Tallarida, E. Tresso and E. Mez- zetti	238 (2004) 485	Study of interfacial properties and its effect on magnetization behaviour of Fe/Ni multi-layer structure, R. Gupta, A. Gupta, S.M. Chaudhari, M. Gupta and P. Allenspach	238 (2004) 254
Doping effects		Gallium	
Erbium-doped thin amorphous carbon films prepared by mixed CVD sputtering, G. Speranza, L. Calliari, M. Ferrari, A. Chiasera, K. Tran Ngoc, A.M. Baranov, V.V. Sleptsov, A.A. Nefedov, A.E. Varfolomeev and S.S. Fanchenko	238 (2004) 117	Study of GaN _x As _{1-x} semiconducting films grown by laser pulsed deposition on crystal-line and amorphous substrates, J.A. Cardona-Bedoya, A. Cruz-Orea, J.G. Mendoza-Alvarez, M. Lucero Gomez-Herrera, M.H. Farias and J.A. Diaz	238 (2004) 147

Ni-Mn-Ga films on Si, GaAs and Ni-Mn-Ga single crystals by pulsed laser deposition, A. Hakola, O. Heczko, A. Jaakkola, T.		Structure and interface properties of Mo/B ₄ C/ Si multilayers deposited by rf-magnetron sputtering, A. Patelli, J. Ravagnan, V.	
Kajava and K. Ullakko Photoluminescence studies in highly Te-doped $Ga_{1-x}In_xAs_ySb_{1-y}$ epitaxial layers grown	238 (2004) 155	Rigato, G. Salmaso, D. Silvestrini, E. Bontempi and L.E. Depero Molecular-scale structure fabrication at liquid/	238 (2004) 262
on GaSb by liquid phase epitaxy, J. Diaz- Reyes, J.L. Herrera-Perez, M.L. Gomez- Herrera, J.A. Cardona-Bedoya and J.G. Mendoza-Alvarez	238 (2004) 400	solid interfaces, D. Takajo, T. Nemoto, H. Kurata and S. Isoda Metal-ceramic interfaces: joining silicon nitride-stainless steel, R. Polanco, A. De	238 (2004) 295
	200 (2001) 100	Pablos, P. Miranzo and M.I. Osendi	238 (2004) 506
Gallium arsenide		Ion implantation	
Ni-Mn-Ga films on Si, GaAs and Ni-Mn-Ga single crystals by pulsed laser deposition, A. Hakola, O. Heczko, A. Jaakkola, T. Kajava and K. Ullakko	238 (2004) 155	Physical characteristics and photolumines- cence properties of phosphorous-implanted ZnO thin films, CC. Lin, SY. Chen and SY. Cheng	238 (2004) 405
Gold		31. Cheng	238 (2004) 403
First principles simulations of Cu and Au deposition on α-Al ₂ O ₃ (0 0 0 1) surface,		Ion scattering	
N. Cruz Hernández and J.F. Sanz	238 (2004) 228	The effect of promoters on the electronic struc- ture of ruthenium catalysts supported on carbon, M. Guraya, S. Sprenger, W.	
Indium		Rarog-Pilecka, D. Szmigiel, Z. Kowalczyk	222 (2004) 77
Photoluminescence studies in highly Te-doped Ga _{1-x} In _x As _y Sb _{1-y} epitaxial layers grown on GaSb by liquid phase epitaxy, J. Diaz-Reyes, J.L. Herrera-Perez, M.L. Gomez-		and M. Muhler Structure and interface properties of Mo/B ₄ C/ Si multilayers deposited by rf-magnetron sputtering, A. Patelli, J. Ravagnan, V.	238 (2004) 77
Herrera, J.A. Cardona-Bedoya and J.G. Mendoza-Alvarez	238 (2004) 400	Rigato, G. Salmaso, D. Silvestrini, E. Bon- tempi and L.E. Depero Surface segregation phenomena of solute ele- ments in Al-Pb and Al-Fe dilute binary	238 (2004) 262
Infrared spectroscopy		alloys, H. Tsubakino, A. Nogami, Y. Yama- moto, A. Yamamoto, M. Terasawa, T. Mita-	
Optical and structural properties of amorphous silicon-carbon films for optoelectronic applications, T. Stapinski, B. Swatowska,		mura, A. Kinomura and Y. Horino	238 (2004) 464
S. Kluska and E. Walasek	238 (2004) 367	Iron	
Isomeric states of polar molecules on ionic surfaces: electrostatic model and FTIR studies, P.Yu. Storozheva, V.S. Yanko, A.A. Tsyganenko, G. Turnes Palomino, M.		Study of interfacial properties and its effect on magnetization behaviour of Fe/Ni multi- layer structure, R. Gupta, A. Gupta, S.M.	
Rodríguez Delgado, C. Otero Areán	238 (2004) 390	Chaudhari, M. Gupta and P. Allenspach	238 (2004) 254
Infrared characterization of strontium titanate thin films, B.G. Almeida, A. Pietka and J.A. Mendes	238 (2004) 395	Surface segregation phenomena of solute ele- ments in Al-Pb and Al-Fe dilute binary alloys, H. Tsubakino, A. Nogami, Y. Yama-	
Effect of radiation and thermal treatment on structural and transport parameters for cellulose regenerated membranes, M.I. Váquez, P. Galán, J. Casado, M.J. Ariza	250 (2301) 555	moto, A. Yamamoto, M. Terasawa, T. Mitamura, A. Kinomura and Y. Horino	238 (2004) 464
and J. Benavente	238 (2004) 415	Laser processing	
Interfaces		Dry laser cleaning of mechanically thin films, F. Bloisi, A.C. Barone and L. Vicari	238 (2004) 121
Study of interfacial properties and its effect on magnetization behaviour of Fe/Ni multi- layer structure, R. Gupta, A. Gupta, S.M.		Numerical simulation of surface deformation and residual stresses fields in laser shock processing experiments, J.L. Ocaña, M.	
Chaudhari, M. Gupta and P. Allenspach	238 (2004) 254	Morales, C. Molpeceres and J. Torres	238 (2004) 242

Mesoscopic modelling of the interaction of		Magnatic measurements	
infrared lasers with composite materials: an application to human dental enamel, A. Vila Verde, M.M.D. Ramos, M. Stone- ham and R. Mendes Ribeiro Experimental assessment of the influence of irradiation parameters on surface deforma-	238 (2004) 410	 Ni-Mn-Ga films on Si, GaAs and Ni-Mn-Ga single crystals by pulsed laser deposition, A. Hakola, O. Heczko, A. Jaakkola, T. Kajava and K. Ullakko Study of interfacial properties and its effect on 	238 (2004) 155
tion and residual stresses in laser shock processed metallic alloys, J.L. Ocaña, C. Molpeceres, J.A. Porro, G. Gómez and M. Morales	238 (2004) 501	magnetization behaviour of Fe/Ni multi- layer structure, R. Gupta, A. Gupta, S.M. Chaudhari, M. Gupta and P. Allenspach	238 (2004) 254
		Manganese	
Lead		Ni-Mn-Ga films on Si, GaAs and Ni-Mn-Ga	
Energy transfer in PbS quantum dots assem- blies measured by means of spatially resolved photoluminescence, N.O. Dantas,		single crystals by pulsed laser deposition, A. Hakola, O. Heczko, A. Jaakkola, T. Kajava and K. Ullakko	238 (2004) 155
A.F.G. Monte, F. Qu, R.S. Silva and P.C. Morais	238 (2004) 209	Metals	
Surface segregation phenomena of solute ele- ments in Al-Pb and Al-Fe dilute binary alloys, H. Tsubakino, A. Nogami, Y. Yama- moto, A. Yamamoto, M. Terasawa, T. Mita-		Comparison between optical techniques and confocal microscopy for defect detection on thin wires, P. Siegmann, L.M. Sanchez-Brea, J.C. Martinez-Anton and E. Bernabeu	238 (2004) 375
mura, A. Kinomura and Y. Horino	238 (2004) 464	Registration of heavy metal ions and pesticides with ATR planar waveguide enzyme sen-	
Luminescence		sors, A. Nabok, S. Haron and A. Ray Experimental assessment of the influence of	238 (2004) 423
Erbium-doped thin amorphous carbon films prepared by mixed CVD sputtering, G. Speranza, L. Calliari, M. Ferrari, A. Chiasera, K. Tran Ngoc, A.M. Baranov, V.V.		irradiation parameters on surface deforma- tion and residual stresses in laser shock processed metallic alloys, J.L. Ocaña, C. Molpeceres, J.A. Porro, G. Gómez and M. Morales	238 (2004) 501
Sleptsov, A.A. Nefedov, A.E. Varfolomeev			200 (2001) 501
and S.S. Fanchenko Study of GaN_xAs_{1-x} semiconducting films	238 (2004) 117	Molybdenum	
grown by laser pulsed deposition on crystal- line and amorphous substrates, J.A. Car- dona-Bedoya, A. Cruz-Orea, J.G. Mendoza-Alvarez, M. Lucero Gomez-Her-		Structure and interface properties of Mo/B ₄ C/ Si multilayers deposited by rf-magnetron sputtering, A. Patelli, J. Ravagnan, V. Rigato, G. Salmaso, D. Silvestrini, E. Bon-	
rera, M.H. Farias and J.A. Diaz Energy transfer in PbS quantum dots assem-	238 (2004) 147	tempi and L.E. Depero	238 (2004) 262
blies measured by means of spatially resolved photoluminescence, N.O. Dantas,		Monte Carlo simulation	
A.F.G. Monte, F. Qu, R.S. Silva and P.C. Morais Photoluminescence studies in highly Te-doped Ga _{1-x} In _x As _y Sb _{1-y} epitaxial layers grown	238 (2004) 209	Electron inelastic mean free paths and surface excitation parameters for GaAs, C.M. Kwei and Y.C. Li	238 (2004) 151
on GaSb by liquid phase epitaxy, J. Diaz- Reyes, J.L. Herrera-Perez, M.L. Gomez- Herrera, J.A. Cardona-Bedoya and J.G.		Multilayers	
Mendoza-Alvarez Physical characteristics and photoluminescence properties of phosphorous-implanted ZnO thin films, CC. Lin, SY. Chen and	238 (2004) 400	Study of interfacial properties and its effect on magnetization behaviour of Fe/Ni multi-layer structure, R. Gupta, A. Gupta, S.M. Chaudhari, M. Gupta and P. Allenspach	238 (2004) 254
SY. Cheng Characterisation of YAG:Ce powders thermal treated at different temperatures, G. Del Rosario, S. Ohara, L. Mancic and O. Milo-	238 (2004) 405	Structure and interface properties of Mo/B ₄ C/ Si multilayers deposited by rf-magnetron sputtering, A. Patelli, J. Ravagnan, V. Rigato, G. Salmaso, D. Silvestrini, E. Bon-	
sevic	238 (2004) 469	tempi and L.E. Depero	238 (2004) 262

Characterization of silicon-YBCO buffered multilayers grown by sputtering, A. Chio-		Optical properties	
doni, V. Ballarini, D. Botta, C. Camerlingo, F. Fabbri, S. Ferrari, R. Gerbaldo, G. Ghigo, L. Gozzelino, F. Laviano, B. Minetti, C.F. Pirri, G. Tallarida, E. Tresso and E. Mez-		Study of GaN_xAs_{1-x} semiconducting films grown by laser pulsed deposition on crystalline and amorphous substrates, J.A. Cardona-	
zetti	238 (2004) 485	Bedoya, A. Cruz-Orea, J.G. Mendoza- Alvarez, M. Lucero Gomez-Herrera, M.H. Farias and J.A. Diaz	228 (2004) 147
Nanostructure		Optical and structural properties of amorphous silicon-carbon films for optoelectronic applications, T. Stapinski, B. Swatowska,	238 (2004) 147
Energy transfer in PbS quantum dots assem- blies measured by means of spatially resolved photoluminescence, N.O. Dantas,		S. Kluska and E. Walasek Registration of heavy metal ions and pesticides with ATR planar waveguide enzyme sen-	238 (2004) 367
A.F.G. Monte, F. Qu, R.S. Silva and P.C. Morais	238 (2004) 209	sors, A. Nabok, S. Haron and A. Ray	238 (2004) 423
Molecular-scale structure fabrication at liquid/ solid interfaces, D. Takajo, T. Nemoto, H.		Organic substances	
Kurata and S. Isoda	238 (2004) 295	Malandar and atmatus fabrication at limits	
Nickel		Molecular-scale structure fabrication at liquid/ solid interfaces, D. Takajo, T. Nemoto, H. Kurata and S. Isoda	238 (2004) 295
Ni-Mn-Ga films on Si, GaAs and Ni-Mn-Ga single crystals by pulsed laser deposition, A. Hakola, O. Heczko, A. Jaakkola, T.		Oxides	
Kajava and K. Ullakko Study of interfacial properties and its effect on magnetization behaviour of Fe/Ni	238 (2004) 155	Infrared characterization of strontium titanate thin films, B.G. Almeida, A. Pietka and J.A. Mendes	238 (2004) 395
multilayer structure, R. Gupta, A. Gupta, S.M. Chaudhari, M. Gupta and P. Allenspach	238 (2004) 254	 Characterization of silicon-YBCO buffered multilayers grown by sputtering, A. Chio- doni, V. Ballarini, D. Botta, C. Camerlingo, F. Fabbri, S. Ferrari, R. Gerbaldo, G. Ghigo, L. Gozzelino, F. Laviano, B. Minetti, C.F. 	
Nitrides		Pirri, G. Tallarida, E. Tresso and E. Mez- zetti	238 (2004) 485
Study of GaN_xAs_{1-x} semiconducting films grown by laser pulsed deposition on crystalline and amorphous substrates, J.A. Cardona-Bedoya, A. Cruz-Orea, J.G. Mendoza-		Release of a chitosan-hydroxyapatite compo- site loaded with ibuprofen and acetyl-sal- icylic acid submitted to different sterilization treatments, A. Larena, D.A. Cáceres, C. Vicario and A. Fuentes	238 (2004) 518
Alvarez, M. Lucero Gomez-Herrera, M.H.	228 (2004) 147	Caccies, C. Vicario and A. Lucines	250 (2004) 510
Farias and J.A. Diaz Registration of heavy metal ions and pesticides with ATR planar waveguide enzyme sen-	238 (2004) 147	Oxygen	
sors, A. Nabok, S. Haron and A. Ray Metal-ceramic interfaces: joining silicon nitride-stainless steel, R. Polanco, A. De	238 (2004) 423	An intermittent temperature-programmed des- orption method for studying kinetics of	
Pablos, P. Miranzo and M.I. Osendi	238 (2004) 506	desorption from heterogeneous surfaces, F. Gaillard, M. Abdat, J.P. Joly and A. Perrard	238 (2004) 91
Nuclear reaction analysis		Phosphorus	
Structure and interface properties of Mo/B ₄ C/			
Si multilayers deposited by rf-magnetron sputtering, A. Patelli, J. Ravagnan, V. Rigato, G. Salmaso, D. Silvestrini, E. Bontempi and L.E. Depero	238 (2004) 262	Physical characteristics and photolumines- cence properties of phosphorous-implanted ZnO thin films, CC. Lin, SY. Chen and SY. Cheng	238 (2004) 405
John Die Depero	200 (2001) 202	J. Z. Chang	200 (2001) 100

Release of a chitosan-hydroxyapatite compo-		Effect of radiation and thermal treatment on	
site loaded with ibuprofen and acetyl-sal-		structural and transport parameters for cel-	
icylic acid submitted to different		lulose regenerated membranes, M.I.	
sterilization treatments, A. Larena, D.A. Cáceres, C. Vicario and A. Fuentes	238 (2004) 518	Váquez, P. Galán, J. Casado, M.J. Ariza and J. Benavente	238 (2004) 415
Caceres, C. Vicario and A. Fuentes	238 (2004) 318	Use of different surface analysis techniques	230 (2004) 413
DL I		for the study of the photo-degradation	
Photoelectron spectroscopy		of a polymeric matrix composite, A. Larena	220 (2004) 520
		and S. Jimenez de Ochoa	238 (2004) 530
The effect of promoters on the electronic struc-			
ture of ruthenium catalysts supported on carbon, M. Guraya, S. Sprenger, W.		Pulsed laser deposition	
Rarog-Pilecka, D. Szmigiel, Z. Kowalczyk		Study of GaN _x As _{1-x} semiconducting films	
and M. Muhler	238 (2004) 77	grown by laser pulsed deposition on crystal-	
Erbium-doped thin amorphous carbon films		line and amorphous substrates, J.A. Cardona-	
prepared by mixed CVD sputtering, G. Speranza, L. Calliari, M. Ferrari, A. Chia-		Bedoya, A. Cruz-Orea, J.G. Mendoza-	
sera, K. Tran Ngoc, A.M. Baranov, V.V.		Alvarez, M. Lucero Gomez-Herrera, M.H. Farias and J.A. Diaz	238 (2004) 147
Sleptsov, A.A. Nefedov, A.E. Varfolomeev		Ni-Mn-Ga films on Si, GaAs and Ni-Mn-Ga	238 (2004) 147
and S.S. Fanchenko	238 (2004) 117	single crystals by pulsed laser deposition,	
Effect of radiation and thermal treatment on structural and transport parameters for cel-		A. Hakola, O. Heczko, A. Jaakkola, T.	
lulose regenerated membranes, M.I.		Kajava and K. Ullakko Infrared characterization of strontium titanate	238 (2004) 155
Váquez, P. Galán, J. Casado, M.J. Ariza		thin films, B.G. Almeida, A. Pietka and J.A.	
and J. Benavente	238 (2004) 415	Mendes	238 (2004) 395
DL			
Photochemistry		Quantum effects	
Use of different surface analysis techniques for		Energy transfer in PbS quantum dots assem-	
the study of the photo-degradation of a		blies measured by means of spatially	
polymeric matrix composite, A. Larena		resolved photoluminescence, N.O. Dantas, A.F.G. Monte, F. Qu, R.S. Silva and P.C.	
and S. Jimenez de Ochoa	238 (2004) 530	Morais	238 (2004) 209
Plasma processing			
, and the second		Raman scattering	
Evaluation and quantification of reprocessing		Characterization of silicon-YBCO buffered	
modification in single-use devices in inter-		multilayers grown by sputtering, A. Chio-	
ventional cardiology, F. Tessarolo, P. Ferrari, B. Silvia, A. Motta, C. Migliaresi, L.		doni, V. Ballarini, D. Botta, C. Camerlingo, F. Fabbri, S. Ferrari, R. Gerbaldo, G. Ghigo,	
Zennaro, A. Rigo, G.M. Guarrera and G.		L. Gozzelino, F. Laviano, B. Minetti, C.F.	
Nollo	238 (2004) 341	Pirri, G. Tallarida, E. Tresso and E. Mez-	
Optical and structural properties of amorphous		zetti	238 (2004) 485
silicon-carbon films for optoelectronic applications, T. Stapinski, B. Swatowska,			
S. Kluska and E. Walasek	238 (2004) 367	Ruthenium	
		The effect of promoters on the electronic struc-	
Polymers		ture of ruthenium catalysts supported on	
		carbon, M. Guraya, S. Sprenger, W.	
Domain size effects on the thermal properties		Rarog-Pilecka, D. Szmigiel, Z. Kowalczyk	220 (2004) 77
of PS/PMMA blends, G.G. Silva, P.M. de		and M. Muhler	238 (2004) 77
Freitas Rocha, P.S. de Oliveira and B.R.			
Almeida Neves	238 (2004) 64	Scanning tunneling microscopy	
Variability between chitosan membrane surface characteristics as function of its composi-		Scanning probe microscopy experiments in	
tion and environmental conditions, A. Lar-		microgravity, T. Drobek, M. Reiter and	
ena and D.A. Cáceres	238 (2004) 273	W.M. Heckl	238 (2004) 3

Molecular-scale structure fabrication at liquid/ solid interfaces, D. Takajo, T. Nemoto, H.		Sputtering	
Kurata and S. Isoda	238 (2004) 295	Topography induced by sputtering in a mag- netic sector instrument: an AFM and SEM study, E. Iacob, M. Bersani, A. Lui, D.	
Secondary ion mass spectroscopy		Giubertoni, M. Barozzi and M. Anderle Erbium-doped thin amorphous carbon films	238 (2004) 24
Topography induced by sputtering in a mag- netic sector instrument: an AFM and SEM study, E. Iacob, M. Bersani, A. Lui, D. Giubertoni, M. Barozzi and M. Anderle	238 (2004) 24	prepared by mixed CVD sputtering, G. Speranza, L. Calliari, M. Ferrari, A. Chiasera, K. Tran Ngoc, A.M. Baranov, V.V. Sleptsov, A.A. Nefedov, A.E. Varfolomeev and S.S. Fanchenko	238 (2004) 117
Silicon		and S.S. Panchenko	238 (2004) 117
		Steel	
Ni-Mn-Ga films on Si, GaAs and Ni-Mn-Ga			
single crystals by pulsed laser deposition,		Metal-ceramic interfaces: joining silicon	
A. Hakola, O. Heczko, A. Jaakkola, T.		nitride-stainless steel, R. Polanco, A. De	
Kajava and K. Ullakko Structure and interface properties of Mo/B ₄ C/	238 (2004) 155	Pablos, P. Miranzo and M.I. Osendi	238 (2004) 506
Si multilayers deposited by rf-magnetron sputtering, A. Patelli, J. Ravagnan, V. Rigato, G. Salmaso, D. Silvestrini, E. Bon-		Strontium	
tempi and L.E. Depero	238 (2004) 262	Infrared characterization of strontium titanate	
Optical and structural properties of amorphous	200 (200.) 202	thin films, B.G. Almeida, A. Pietka and J.A.	
silicon-carbon films for optoelectronic		Mendes	238 (2004) 395
applications, T. Stapinski, B. Swatowska,			
S. Kluska and E. Walasek	238 (2004) 367	Calabida	
Characterization of silicon-YBCO buffered		Sulphides	
multilayers grown by sputtering, A. Chio-		Energy transfer in PbS quantum dots assem-	
doni, V. Ballarini, D. Botta, C. Camerlingo,		blies measured by means of spatially	
F. Fabbri, S. Ferrari, R. Gerbaldo, G. Ghigo,		resolved photoluminescence, N.O. Dantas,	
L. Gozzelino, F. Laviano, B. Minetti, C.F.		A.F.G. Monte, F. Qu, R.S. Silva and P.C.	
Pirri, G. Tallarida, E. Tresso and E. Mez-	220 (2004) 405	Morais	238 (2004) 209
zetti	238 (2004) 485		,
Metal-ceramic interfaces: joining silicon nitride-stainless steel, R. Polanco, A. De			
Pablos, P. Miranzo and M.I. Osendi	238 (2004) 506	Surface defects	
Pablos, P. Miranzo and M.1. Osendi	236 (2004) 300		
		Comparison between optical techniques and	
Silicon oxide		confocal microscopy for defect detection	
		on thin wires, P. Siegmann, L.M. Sanchez- Brea, J.C. Martinez-Anton and E. Bernabeu	238 (2004) 375
Registration of heavy metal ions and pesticides		Brea, J.C. Martinez-Anton and E. Bernabeu	238 (2004) 373
with ATR planar waveguide enzyme sen-			
sors, A. Nabok, S. Haron and A. Ray	238 (2004) 423	Surface roughness	
Sputter deposition		Multifractal analysis of growing surfaces, A.	
Sputter deposition		Chaudhari, CC. Sanders Yan and SL.	
		Lee	238 (2004) 513
Structure and interface properties of Mo/B ₄ C/		Use of different surface analysis techniques for	
Si multilayers deposited by rf-magnetron		the study of the photo-degradation of a	
sputtering, A. Patelli, J. Ravagnan, V.		polymeric matrix composite, A. Larena	
Rigato, G. Salmaso, D. Silvestrini, E. Bon-	229 (2004) 262	and S. Jimenez de Ochoa	238 (2004) 530
tempi and L.E. Depero	238 (2004) 262		
Characterization of silicon-YBCO buffered multilayers grown by sputtering, A. Chio-		Surface structures	
doni, V. Ballarini, D. Botta, C. Camerlingo,		Surface structures	
F. Fabbri, S. Ferrari, R. Gerbaldo, G. Ghigo,		Comparison between optical techniques and	
L. Gozzelino, F. Laviano, B. Minetti, C.F.		confocal microscopy for defect detection	
Pirri, G. Tallarida, E. Tresso and E. Mez-		on thin wires, P. Siegmann, L.M. Sanchez-	
zetti	238 (2004) 485	Brea, J.C. Martinez-Anton and E. Bernabeu	238 (2004) 375
	, , , , , , , , , , , , , , , , , , , ,		, ,

T.1		Structure and interface properties of Mo/B ₄ C/	
Telurium		Si multilayers deposited by rf-magnetron	
Photoluminescence studies in highly Te-doped		sputtering, A. Patelli, J. Ravagnan, V.	
Ga _{1-x} In _x As _y Sb _{1-y} epitaxial layers grown		Rigato, G. Salmaso, D. Silvestrini, E. Bon-	
on GaSb by liquid phase epitaxy, J. Diaz-		tempi and L.E. Depero	238 (2004) 262
Reyes, J.L. Herrera-Perez, M.L. Gomez-		Characterisation of YAG:Ce powders thermal	
Herrera, J.A. Cardona-Bedoya and J.G.		treated at different temperatures, G. Del	
Mendoza-Alvarez	238 (2004) 400	Rosario, S. Ohara, L. Mancic and O. Milo- sevic	238 (2004) 469
		Characterization of silicon-YBCO buffered	238 (2004) 409
Thermal desorption		multilayers grown by sputtering, A. Chio-	
		doni, V. Ballarini, D. Botta, C. Camerlingo,	
An intermittent temperature-programmed des-		F. Fabbri, S. Ferrari, R. Gerbaldo, G. Ghigo,	
orption method for studying kinetics of desorption from heterogeneous surfaces,		L. Gozzelino, F. Laviano, B. Minetti, C.F.	
F. Gaillard, M. Abdat, J.P. Joly and A.		Pirri, G. Tallarida, E. Tresso and E. Mez-	
Perrard	238 (2004) 91	zetti	238 (2004) 485
	200 (2001)	Metal-ceramic interfaces: joining silicon	
Thin films		nitride-stainless steel, R. Polanco, A. De	229 (2004) 506
Thin films		Pablos, P. Miranzo and M.I. Osendi	238 (2004) 506
Ni-Mn-Ga films on Si, GaAs and Ni-Mn-Ga			
single crystals by pulsed laser deposition,		X-ray scattering	
A. Hakola, O. Heczko, A. Jaakkola, T.			
Kajava and K. Ullakko	238 (2004) 155	Study of interfacial properties and its effect on	
Infrared characterization of strontium titanate		magnetization behaviour of Fe/Ni multi-	
thin films, B.G. Almeida, A. Pietka and J.A.		layer structure, R. Gupta, A. Gupta, S.M.	
Mendes	238 (2004) 395	Chaudhari, M. Gupta and P. Allenspach	238 (2004) 254
Characterization of silicon-YBCO buffered			
multilayers grown by sputtering, A. Chio- doni, V. Ballarini, D. Botta, C. Camerlingo,		Yttrium	
F. Fabbri, S. Ferrari, R. Gerbaldo, G. Ghigo,		1 ti tum	
L. Gozzelino, F. Laviano, B. Minetti, C.F.		Characterization of silicon-YBCO buffered	
Pirri, G. Tallarida, E. Tresso and E. Mez-		multilayers grown by sputtering, A. Chio-	
zetti	238 (2004) 485	doni, V. Ballarini, D. Botta, C. Camerlingo,	
		F. Fabbri, S. Ferrari, R. Gerbaldo, G. Ghigo,	
Tin oxides		L. Gozzelino, F. Laviano, B. Minetti, C.F.	
		Pirri, G. Tallarida, E. Tresso and E. Mez-	
An intermittent temperature-programmed des-		zetti	238 (2004) 485
orption method for studying kinetics of			
desorption from heterogeneous surfaces,		Zeolites	
F. Gaillard, M. Abdat, J.P. Joly and A. Perrard	229 (2004) 01	Zeomes	
Perrard	238 (2004) 91	An intermittent temperature programmed des	
T'.		An intermittent temperature-programmed des- orption method for studying kinetics of	
Titanium		desorption from heterogeneous surfaces,	
Infrared characterization of strontium titanate		F. Gaillard, M. Abdat, J.P. Joly and A.	
thin films, B.G. Almeida, A. Pietka and J.A.		Perrard	238 (2004) 91
Mendes	238 (2004) 395	Isomeric states of polar molecules on ionic	
	(,	surfaces: electrostatic model and FTIR stu-	
X-ray diffraction		dies, P.Yu. Storozheva, V.S. Yanko, A.A.	
A-ray diffraction		Tsyganenko, G. Turnes Palomino, M.	220 (2004) 200
Ni Ma Co films on Si CoAs and Ni Ma Co		Rodríguez Delgado, C. Otero Areán	238 (2004) 390
Ni-Mn-Ga films on Si, GaAs and Ni-Mn-Ga single crystals by pulsed laser deposition,			
A. Hakola, O. Heczko, A. Jaakkola, T.		Zinc oxide	
Kajava and K. Ullakko	238 (2004) 155		
Study of interfacial properties and its effect on		Physical characteristics and photolumines-	
magnetization behaviour of Fe/Ni multi-		cence properties of phosphorous-implanted	
layer structure, R. Gupta, A. Gupta, S.M.		ZnO thin films, CC. Lin, SY. Chen and	
Chaudhari, M. Gupta and P. Allenspach	238 (2004) 254	SY. Cheng	238 (2004) 405